

SANSHA ELECTRIC MFG.CO.,LTD.

### SiC MOSFET Module SPECIFICATION

1. PART NUMBER

FCA100AC120

2. DEVICE TYPE

Isolated module

3. RATINGS AND CHARACTERISTICS

100A

1200V

See spec sheet and graphs attached.

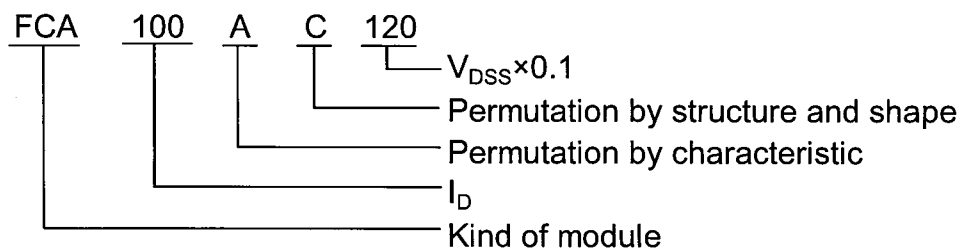
4. OUTLINE DRAWING

See Drawing No.G00A0197600

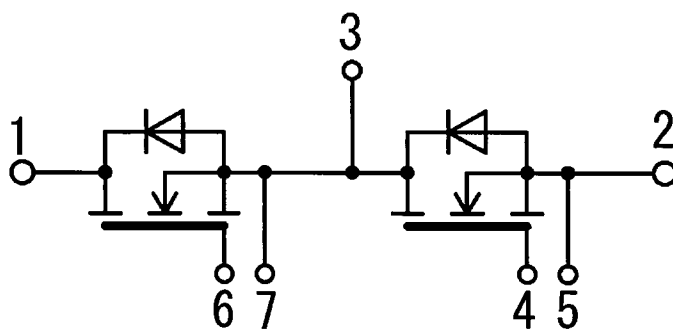
5. TEST PERFORMED BY

JEITA ED-4561B

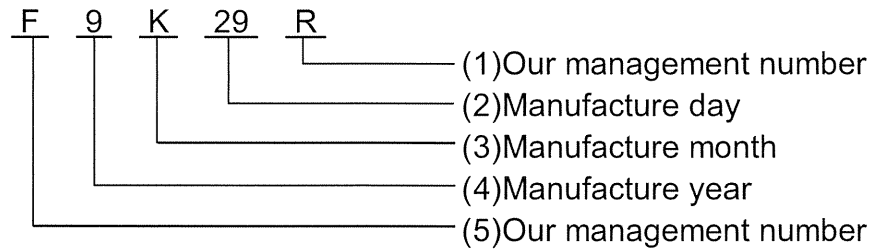
6. DEFINITION OF PART NUMBER



7. CIRCUIT DIAGRAM



## 8. DEFINITION OF LOT NUMBER



(1) Our management number.

Note "R" indicate RoHS-compliant products.

(2) Manufacture day.

"01-31" : From 1th to 31th.

Example "29" : 29th.

(3) Manufacture month.

"A - L" : From January to December.

Example "K" : November

(4) Manufacture year.

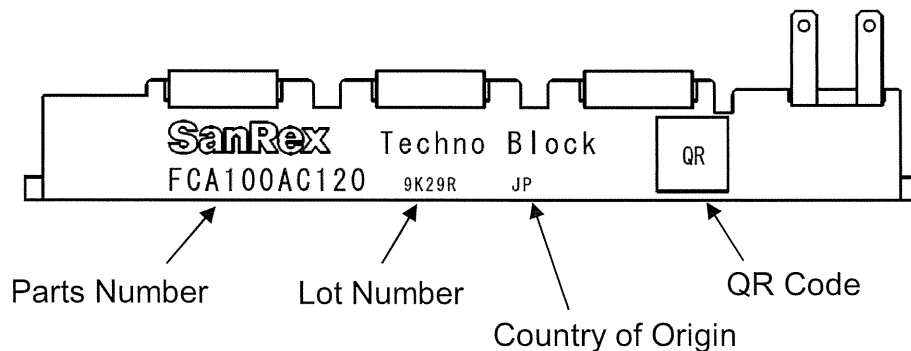
The number of the end of A.D.

Example "9" : 2019 years.

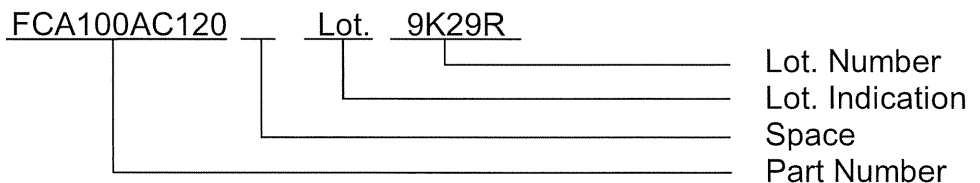
(5) Our management number.

Some cases have no entry at all.

## 9. PRODUCT PRINTING SPECIFICATIONS



### QR-CODE INFORMATION



## 10. STANDARD

UL1557  
RoHS Compliant

# FCA100AC120

## ■ Maximum Ratings (T<sub>j</sub>=25°C unless otherwise specified)

Item	Symbol	Unit	Ratings	Conditions
Drain-Source Voltage	V <sub>DSS</sub>	V	1200	
Gate-Source Voltage(+)	V <sub>GSS</sub>	V	22	
Gate-Source Voltage(-)		V	-7	
Drain Current	I <sub>D</sub>	A	100	V <sub>GS</sub> =20V, T <sub>c</sub> =90°C, DC
	I <sub>D(pulse)</sub>	A	300	Pulse
Source Current	I <sub>S</sub>	A	100	V <sub>GS</sub> =-5V, T <sub>c</sub> =90°C, DC
	I <sub>S(pulse)</sub>	A	300	Pulse
Total Power Dissipation	P <sub>tot</sub>	W	625	T <sub>c</sub> =25°C
Operating Junction Temperature	T <sub>j</sub>	°C	-40~+150	
Storage Temperature	T <sub>stg</sub>	°C	-40~+125	
Isolation Voltage	V <sub>iso</sub>	V	2500	AC, RMS, 1min

## ■ Electrical Characteristics (T<sub>j</sub>=25°C unless otherwise specified)

Item	Symbol	Unit	Ratings			Conditions
			Min.	Typ.	Max.	
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V	1200			V <sub>GS</sub> =0V, I <sub>D</sub> =200μA
Static Drain-Source On-State Voltage	V <sub>DS(on)</sub>	V		0.68	1.40	V <sub>GS</sub> =20V, I <sub>D</sub> =100A
				0.74	1.50	V <sub>GS</sub> =20V, I <sub>D</sub> =100A, T <sub>j</sub> =150°C
On-State Resistance	R <sub>DS(on)</sub>	mΩ		6.8	14.0	V <sub>GS</sub> =20V, I <sub>D</sub> =100A
				7.4	15.0	V <sub>GS</sub> =20V, I <sub>D</sub> =100A, T <sub>j</sub> =150°C
Drain Cutoff Current	I <sub>DSS</sub>	μA			200	V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V	3	4	5	V <sub>DS</sub> =10V, I <sub>D</sub> =3mA
Gate-Source Leakage Current	I <sub>GSS</sub>	nA			200	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V
Switching Characteristics	t <sub>d(on)</sub>	ns		58		I <sub>D</sub> =100A, V <sub>DS</sub> =600V, V <sub>GS</sub> =+20V/-5V, R <sub>G</sub> =3.3Ω, L=126μH
	t <sub>r</sub>	ns		33		
	t <sub>rr</sub>	ns		47		
	t <sub>d(off)</sub>	ns		121		
	t <sub>f</sub>	ns		49		
Total Gate Charge	Q <sub>G</sub>	nC		660		I <sub>D</sub> =100A, V <sub>DS</sub> =600V, V <sub>GS</sub> =+20V/-5V
Input Capacitance	C <sub>iss</sub>	nF		17.2		V <sub>DS</sub> =20V, V <sub>GS</sub> =0V, f=100kHz
Output Capacitance	C <sub>oss</sub>	nF		5.0		
Reverse Transfer Capacitance	C <sub>rss</sub>	nF		0.6		
Source-Drain Voltage	V <sub>SD</sub>	V		2.60	2.90	V <sub>GS</sub> =-5V, I <sub>S</sub> =100A
				2.62	2.95	V <sub>GS</sub> =-5V, I <sub>S</sub> =100A, T <sub>j</sub> =150°C
Total Capacitive Charge	Q <sub>c</sub>	nC		2300		I <sub>SD</sub> =100A, V <sub>DS</sub> =600V, di <sub>SD</sub> /dt=2400A/μs, V <sub>GS</sub> =-5V
Internal Gate Resistance	R <sub>G(int)</sub>	Ω		0.4		
Internal Stray Inductance	L <sub>s</sub>	nH		20		Between terminals 1 and 2

## ■ Thermal Characteristics (T<sub>j</sub>=25°C unless otherwise specified)

Junction-to-Case Thermal Resistance	R <sub>th(j-c)</sub>	°C/W			0.2	Per leg
Case-to-Heat sink Thermal Resistance	R <sub>th(c-f)</sub>	°C/W		0.06		Per module Thermal conductivity = 9×10 <sup>-3</sup> W/cm·°C

## ■ Mechanical Characteristics (T<sub>j</sub>=25°C unless otherwise specified)

Weight	-	g		130		
Mounting Torque(M5)	-	N·m			2.7	Main terminals and mounting to heat sink Recommended value 1.5~2.5N·m

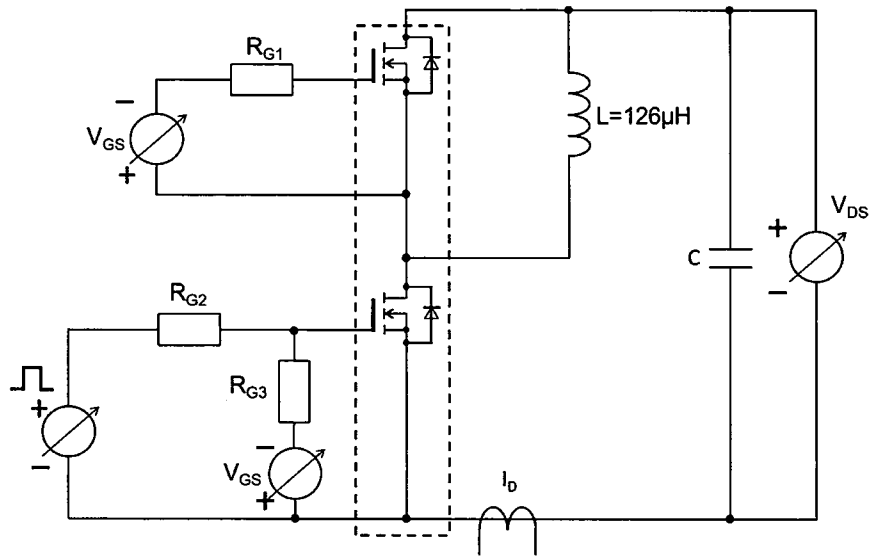


Fig.1 Inductive load switching time test circuit

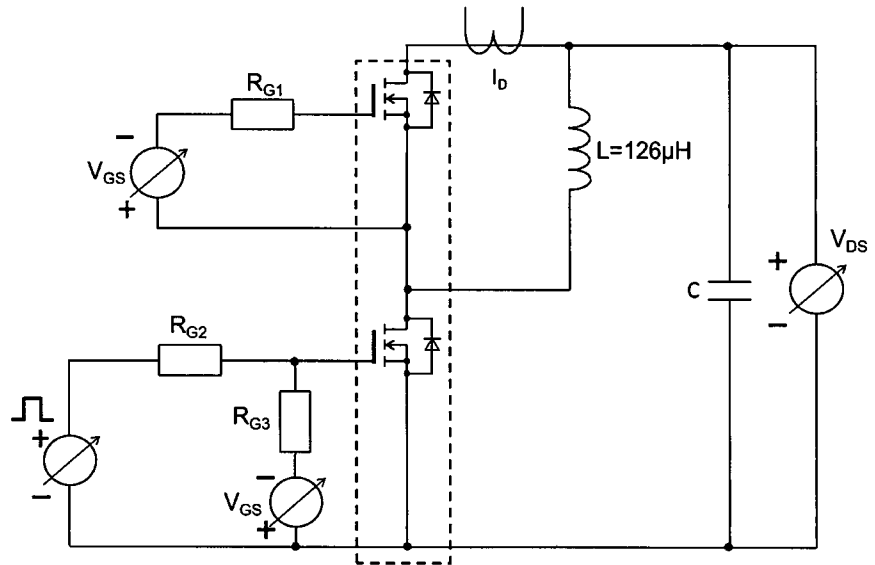


Fig.2 Inductive load recovery switching time test circuit

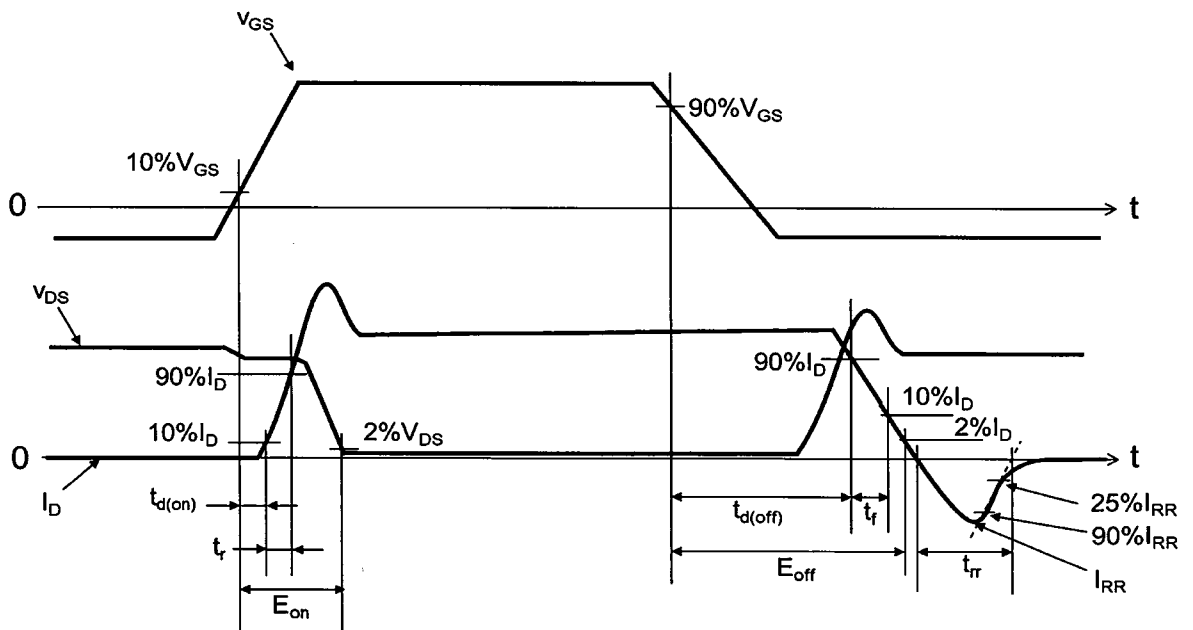


Fig.3 Switching waveform at the time of Inductive load

Fig.4 Output Characteristics (Typical)

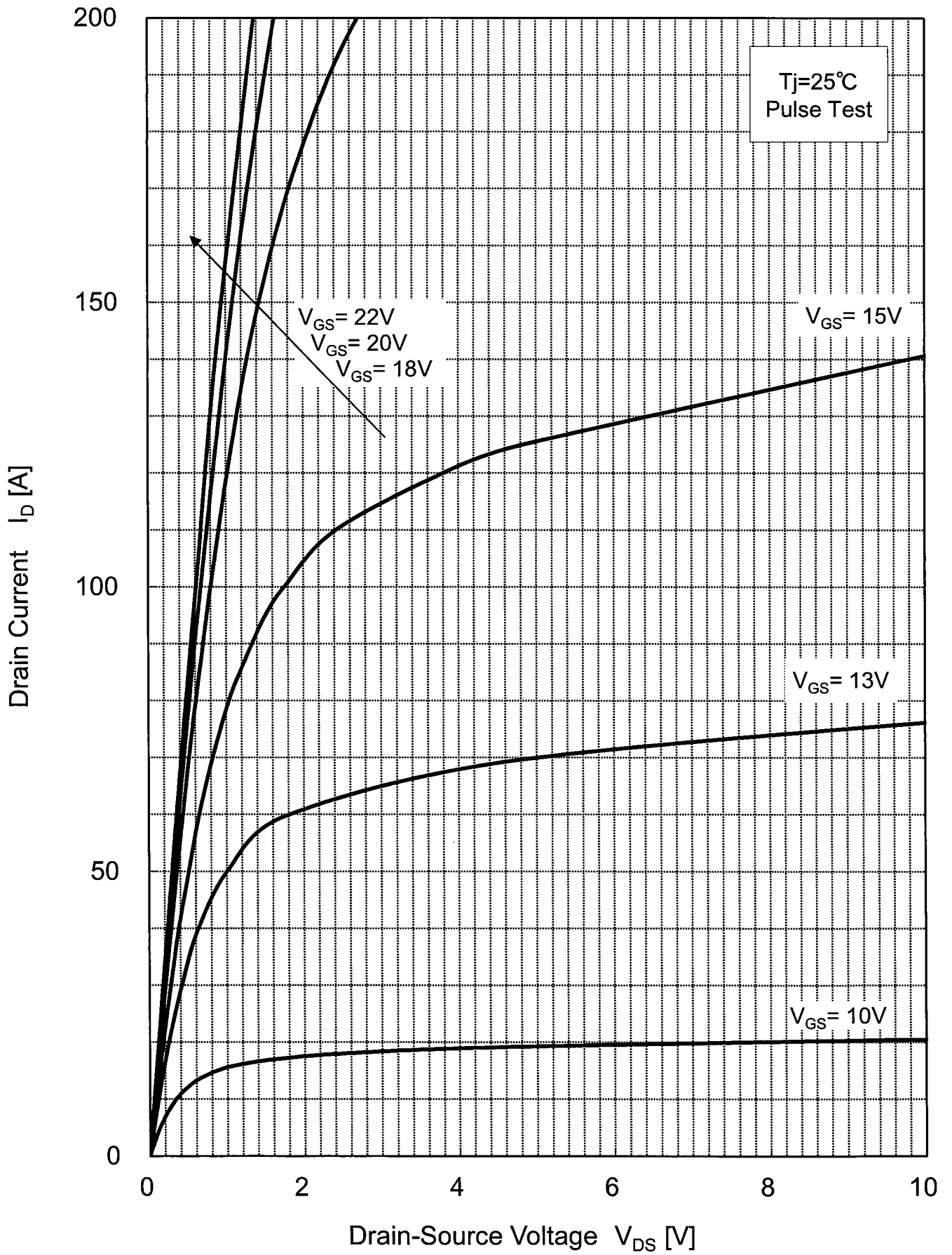
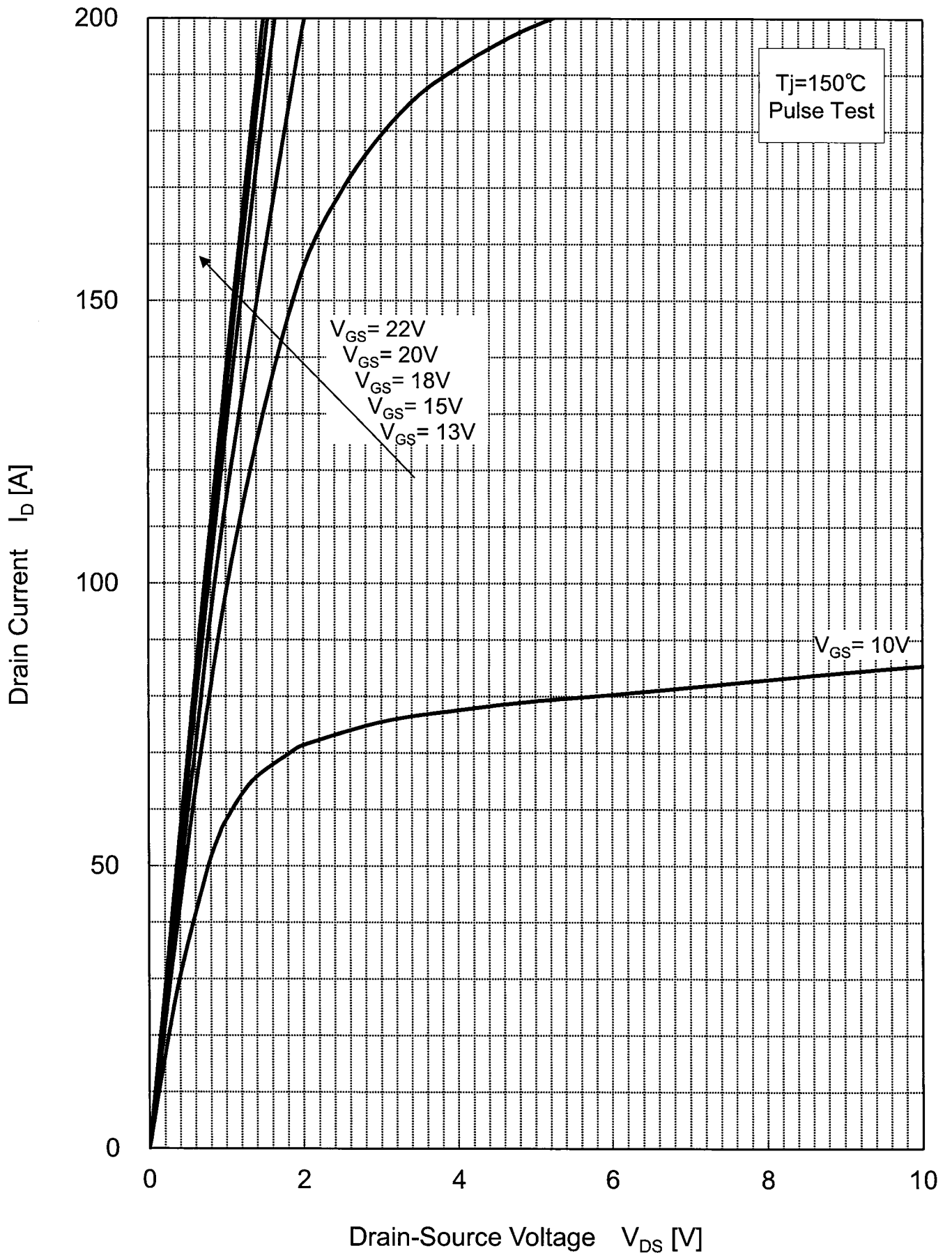


Fig.5 Output Characteristics (Typical)



**Fig.6 Transfer Characteristics (Typical)**

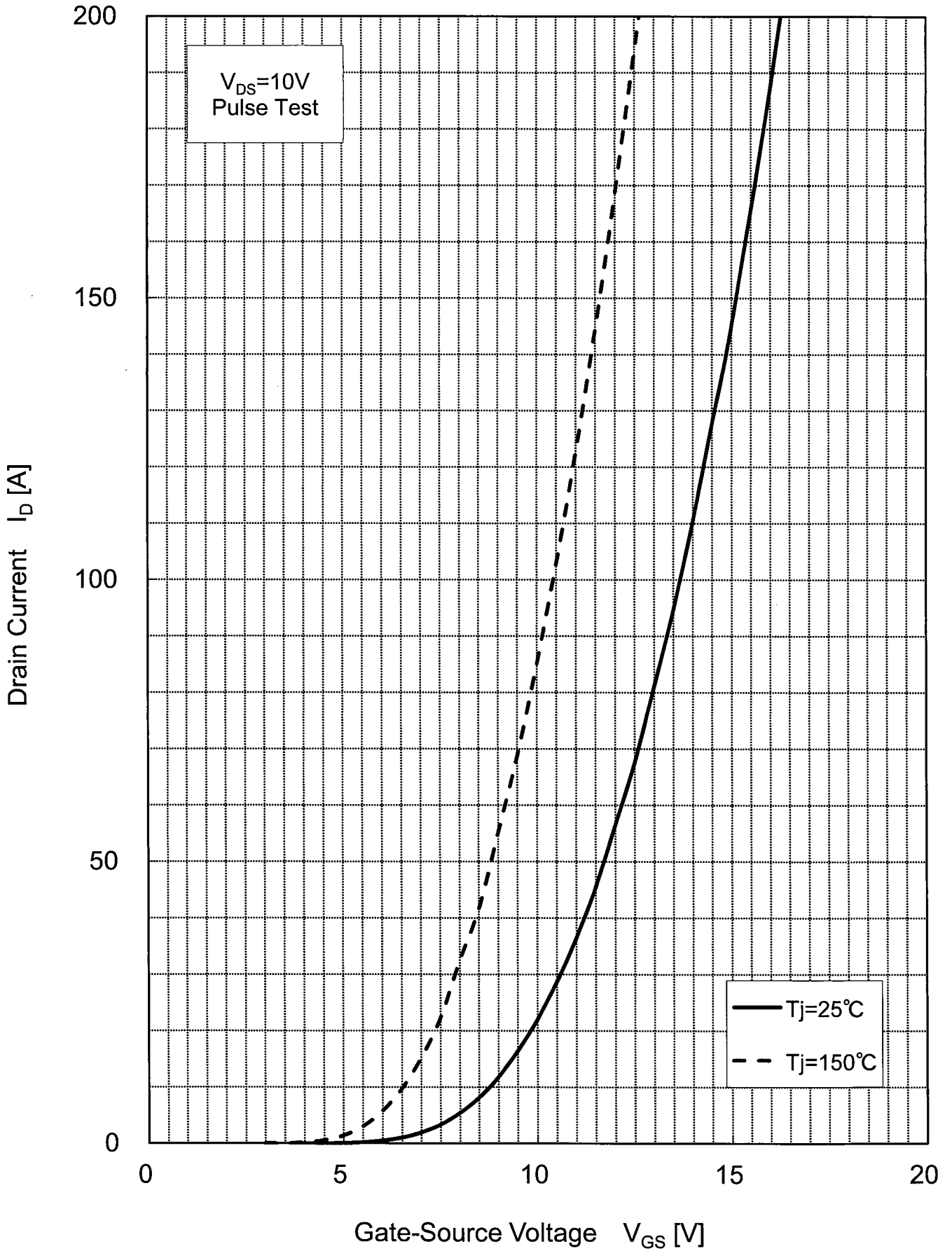


Fig.7 3<sup>rd</sup> Quadrant Characteristics (Typical)

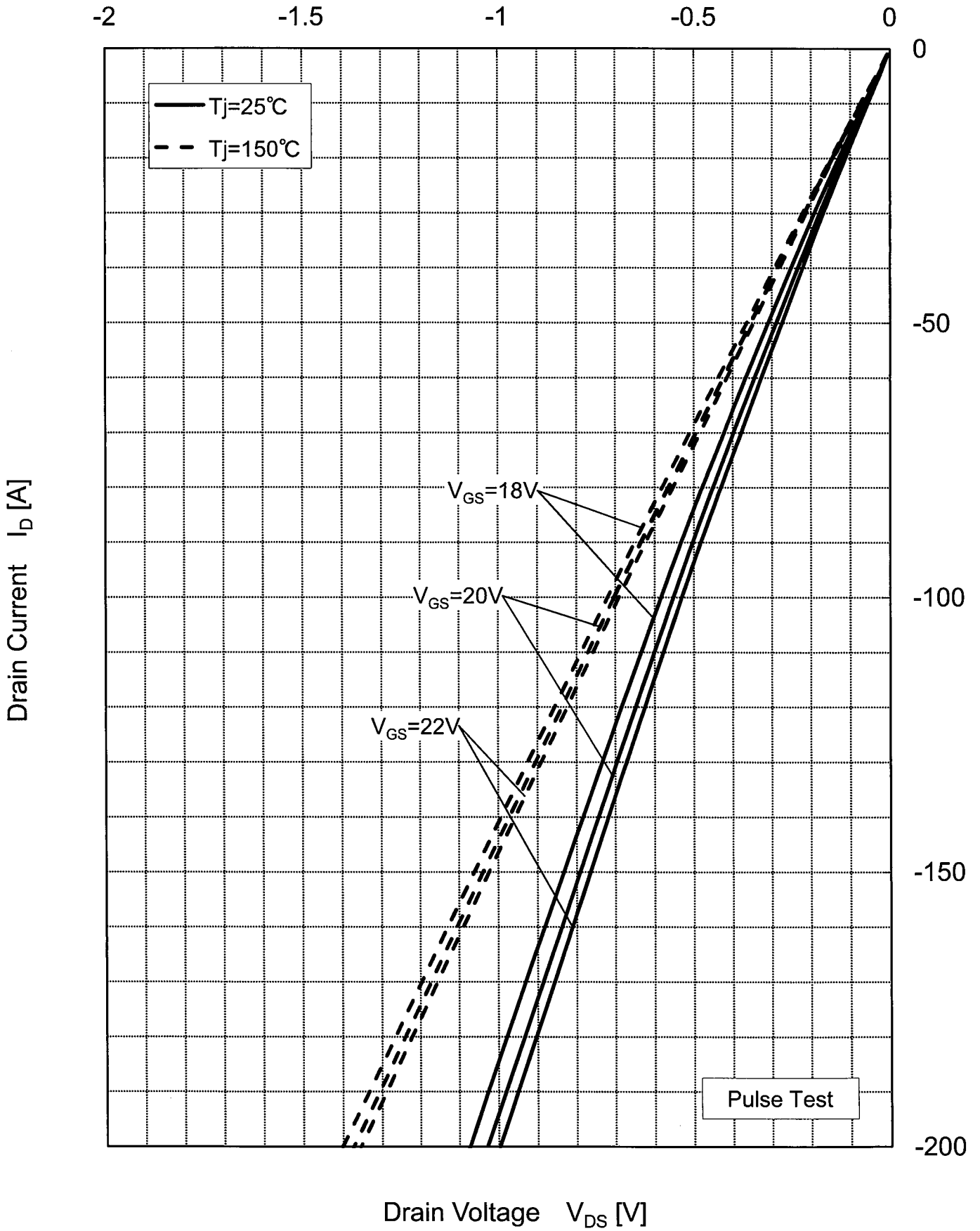
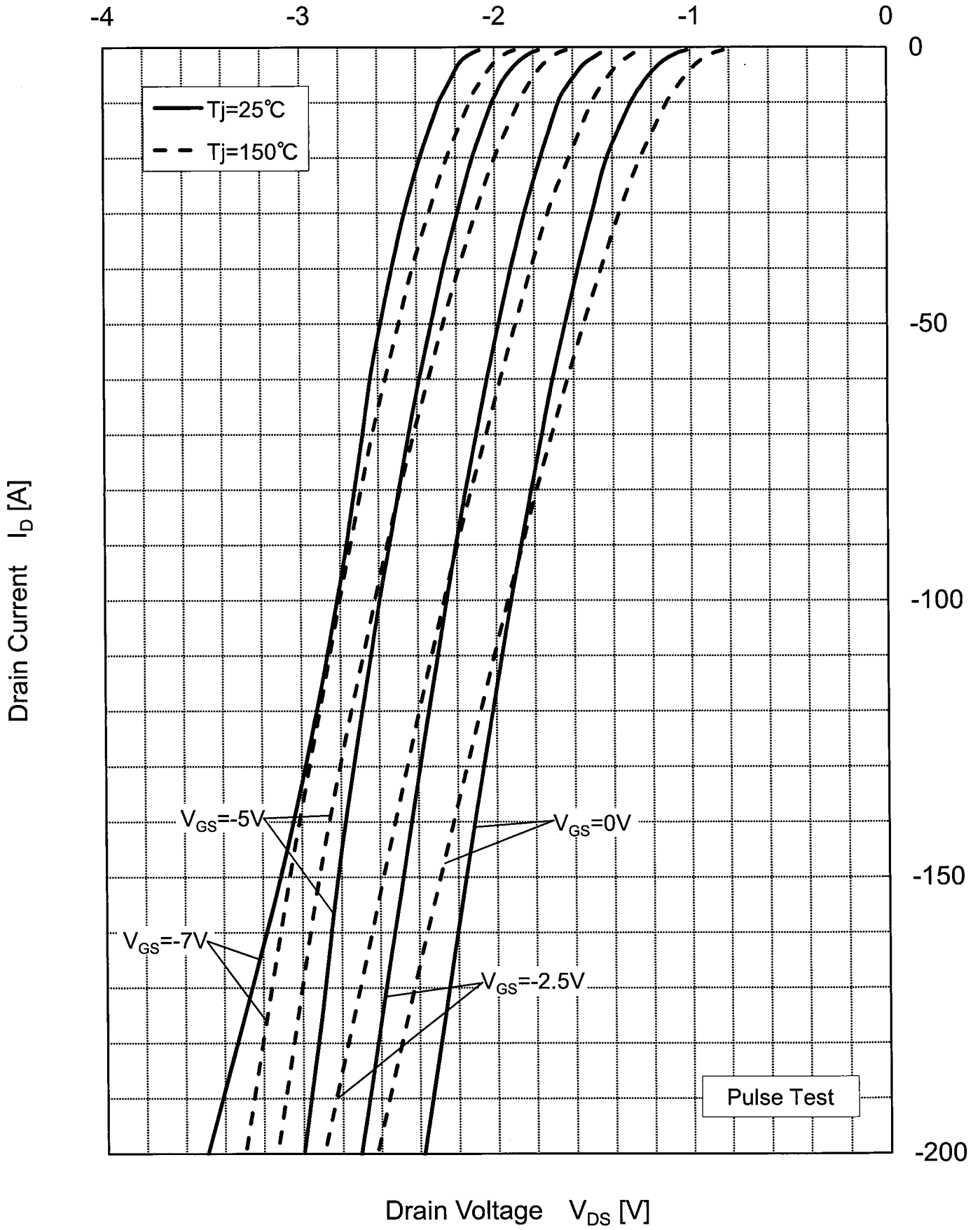
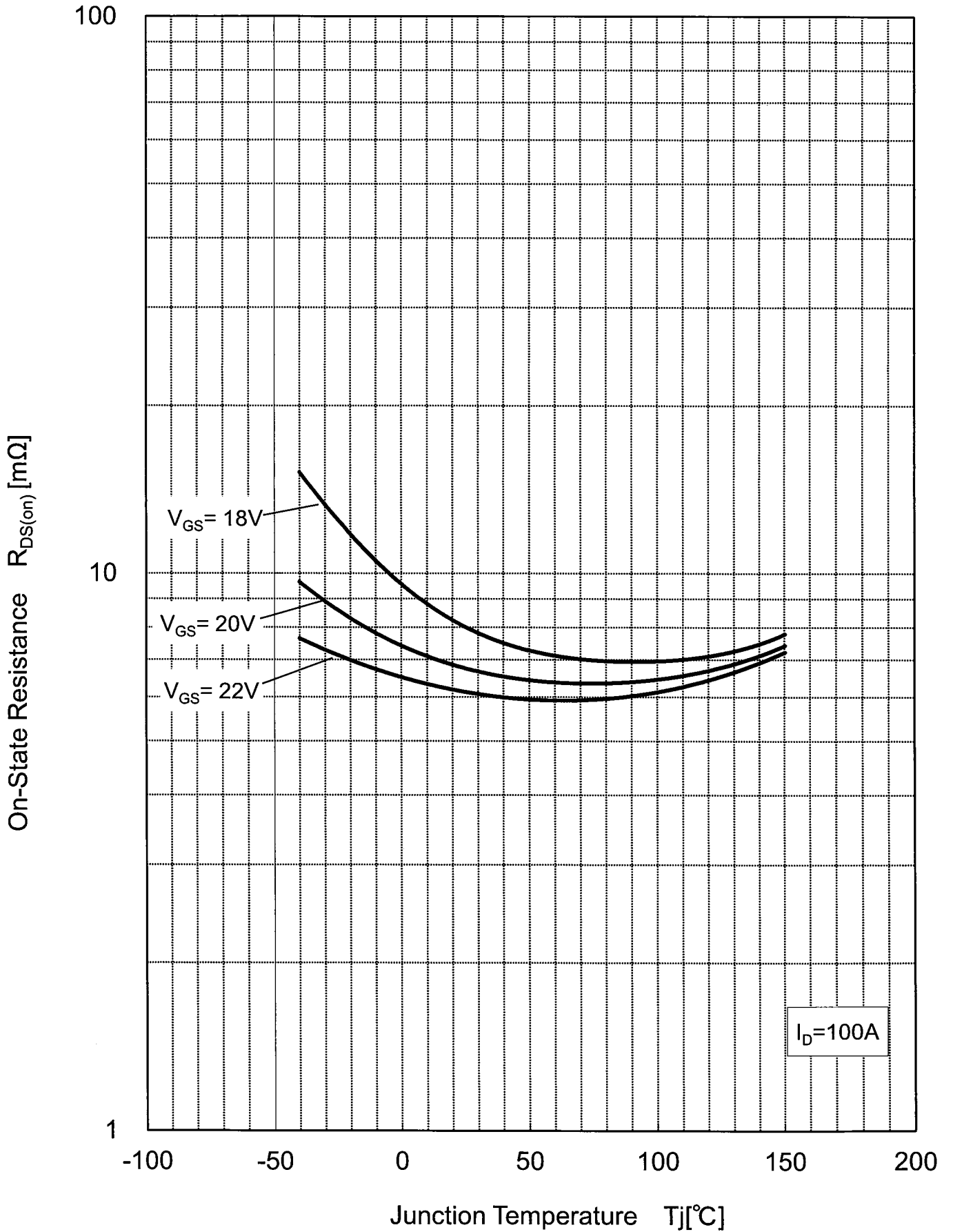




Fig.8 3<sup>rd</sup> Quadrant Characteristics (Typical)



**Fig.9 On-State Resistance vs Junction Temperature (Typical)**



**Fig.10 Source-Drain Voltage vs Junction Temperature (Typical)**

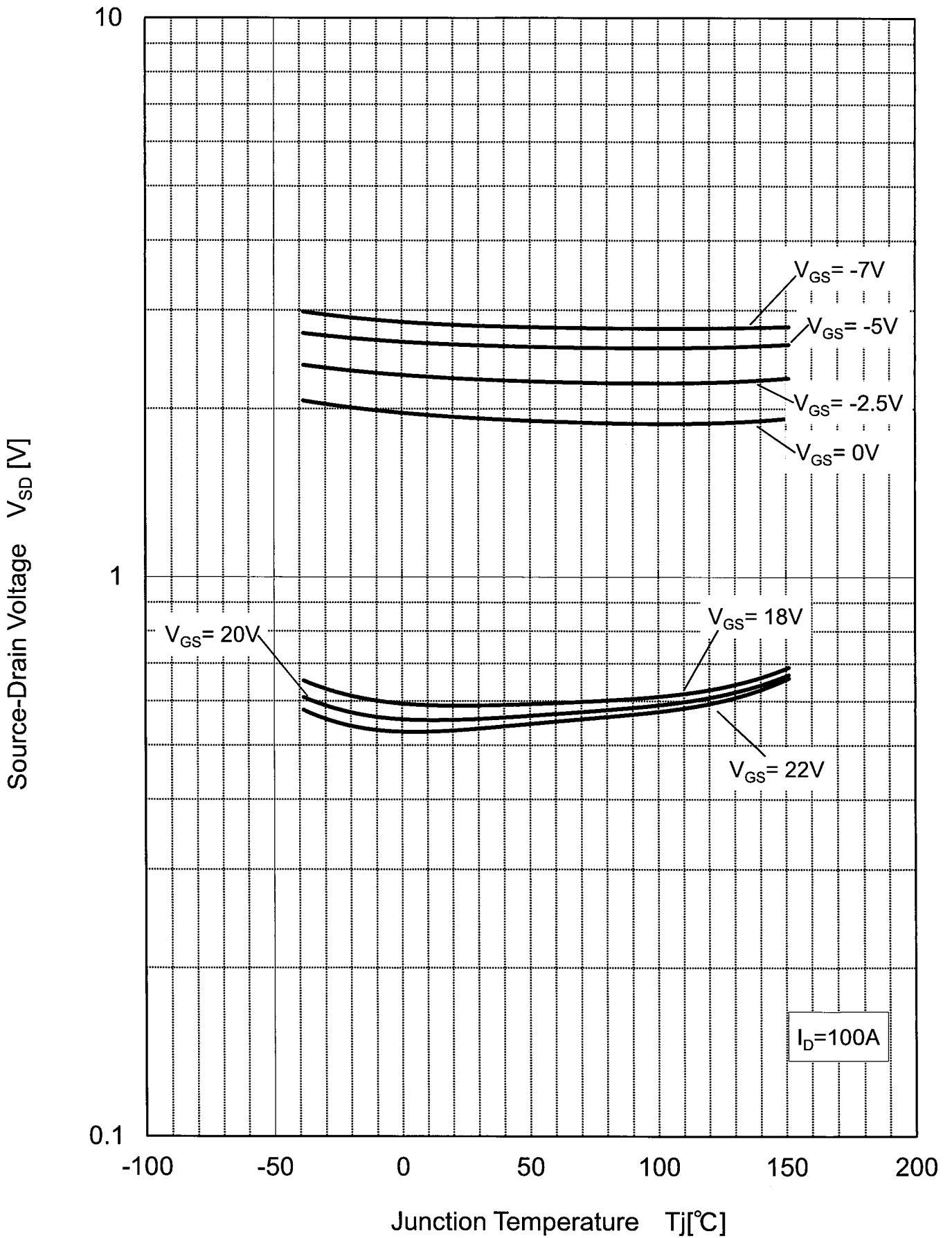
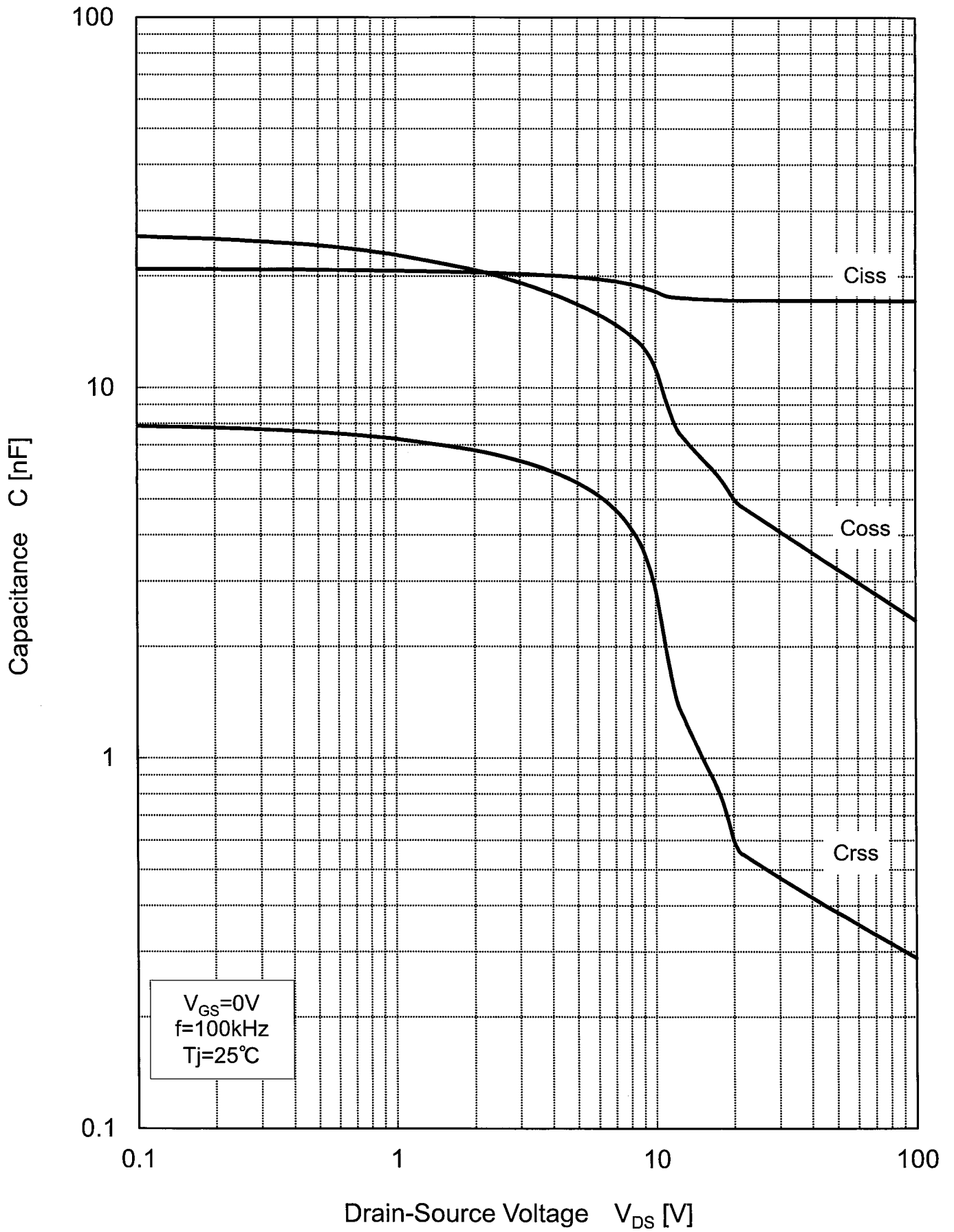


Fig.11 Capacitance (Typical)



**Fig.12 Gate Charge Characteristics (Typical)**

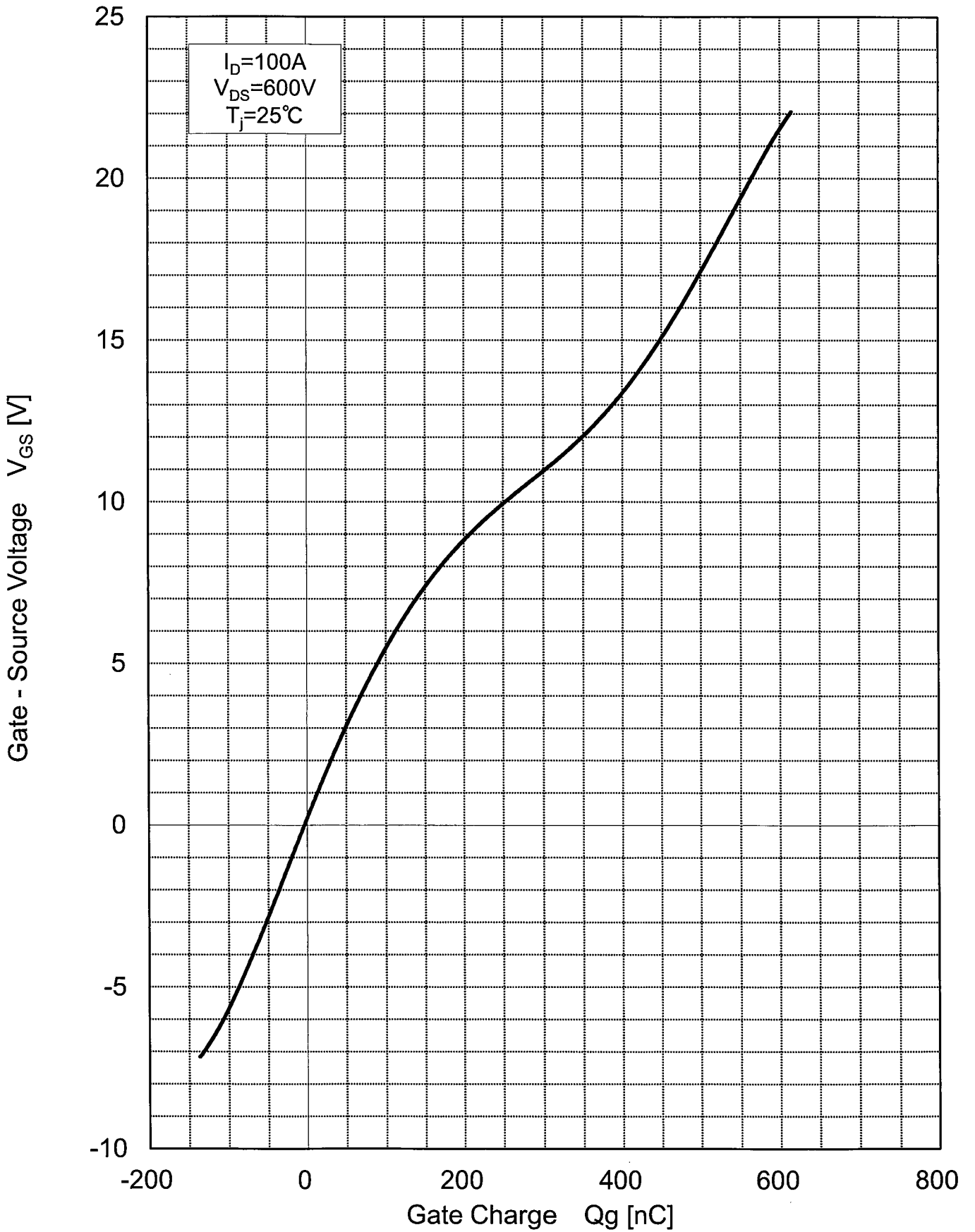
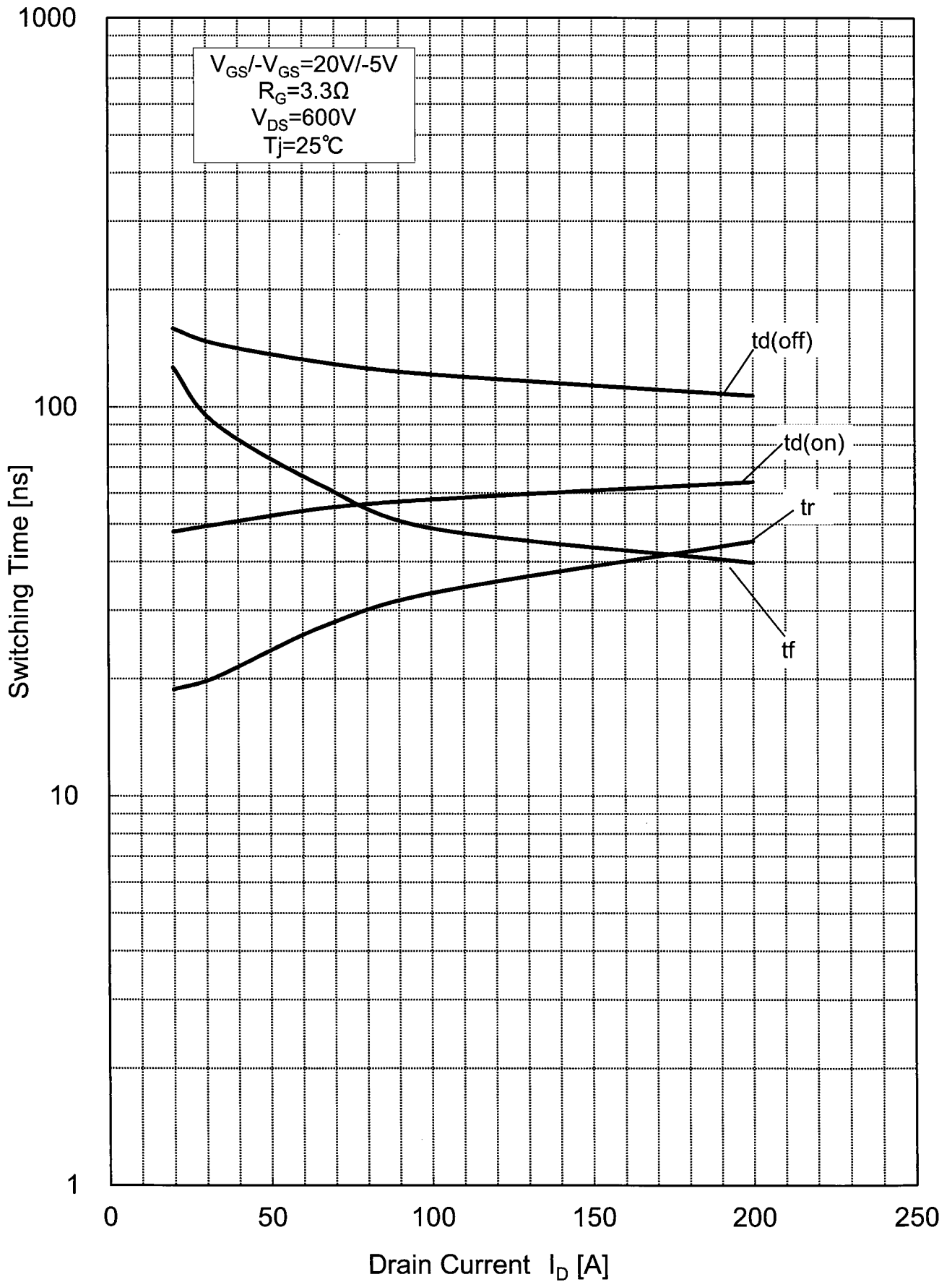


Fig.13 Switching Time vs Drain Current (Typical)



**Fig.14 Switching Time vs Drain Current (Typical)**

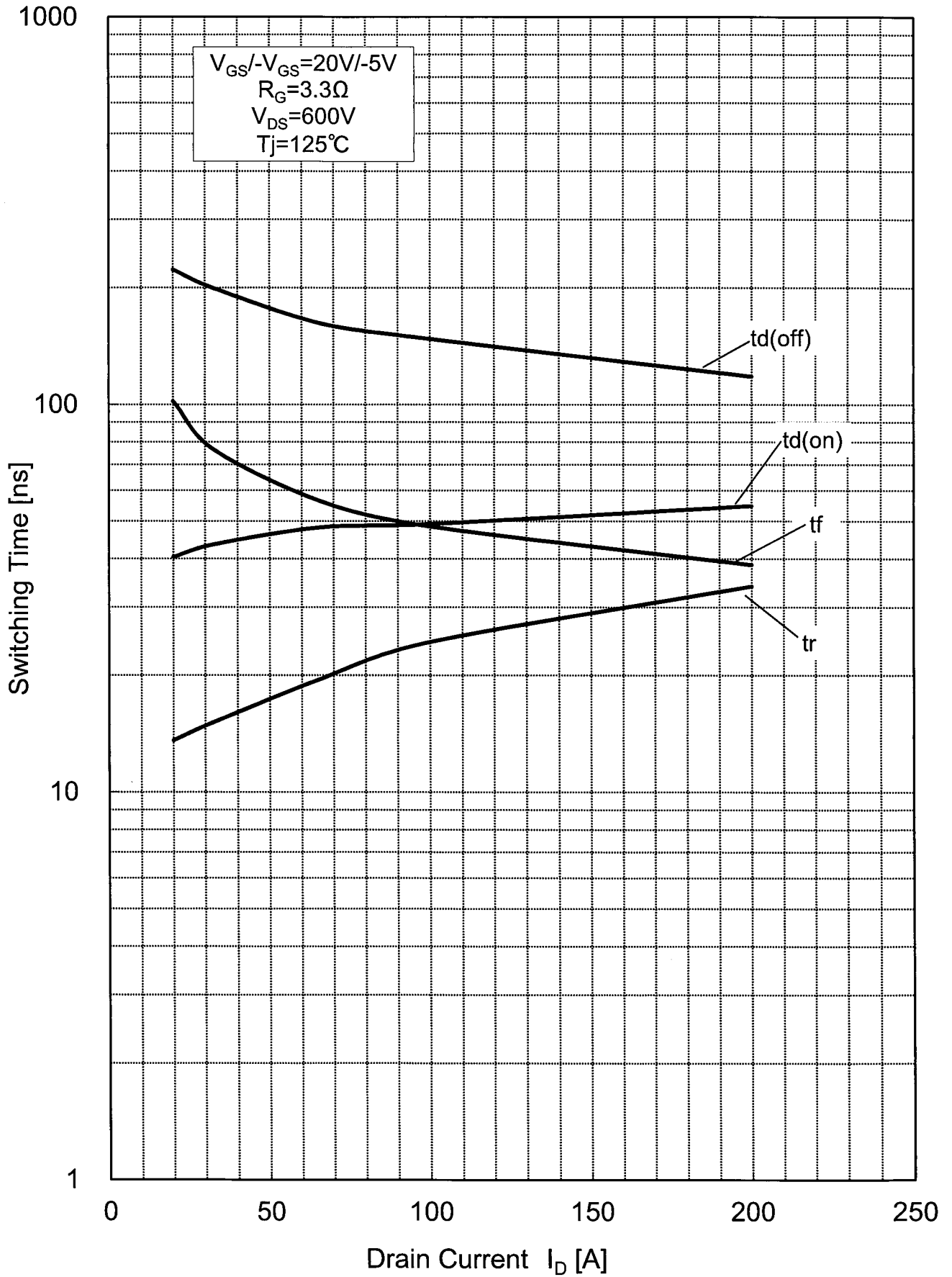


Fig.15 Switching Time vs Drain Current (Typical)

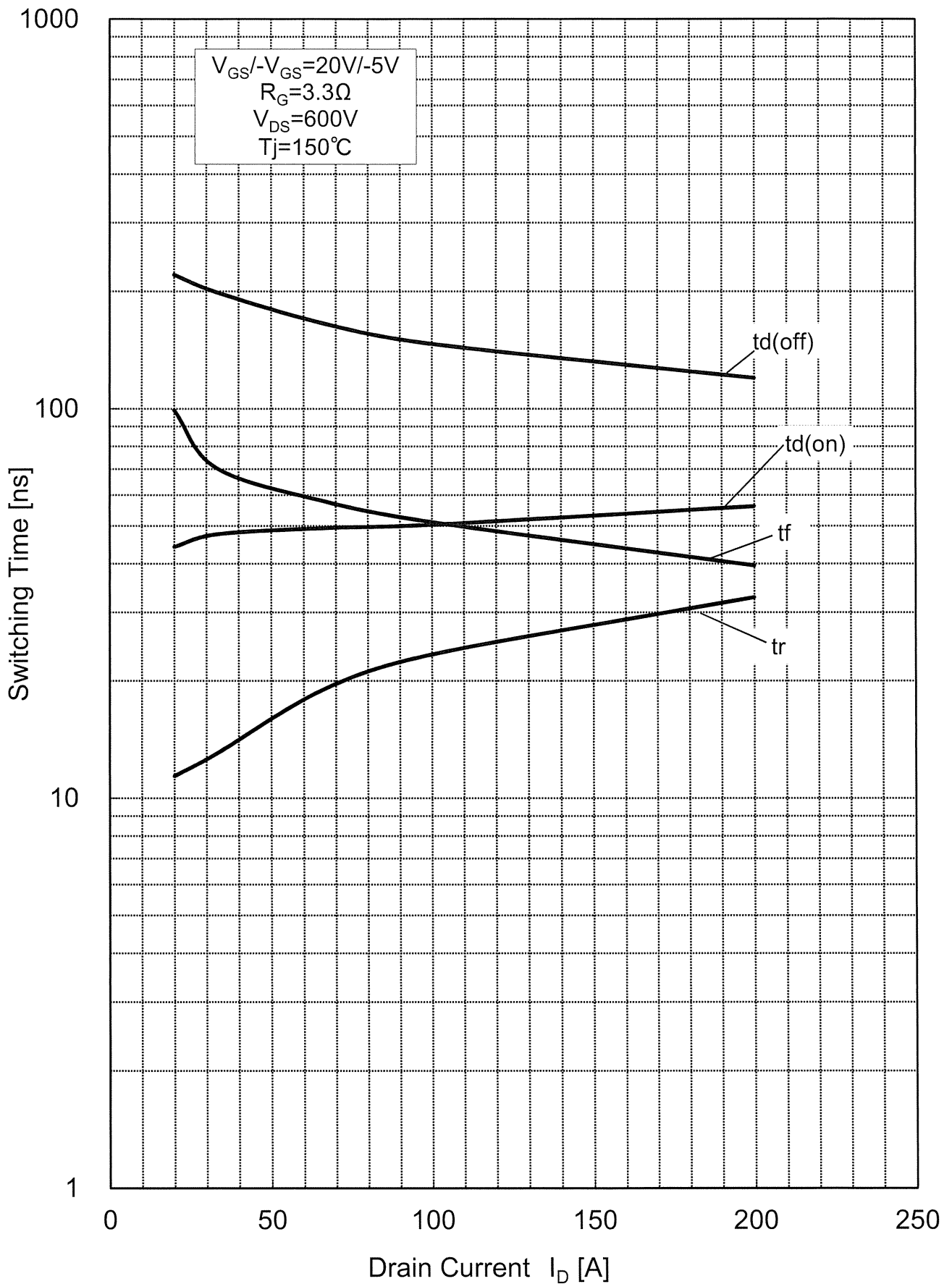




Fig.16 Switching Loss vs Drain Current (Typical)

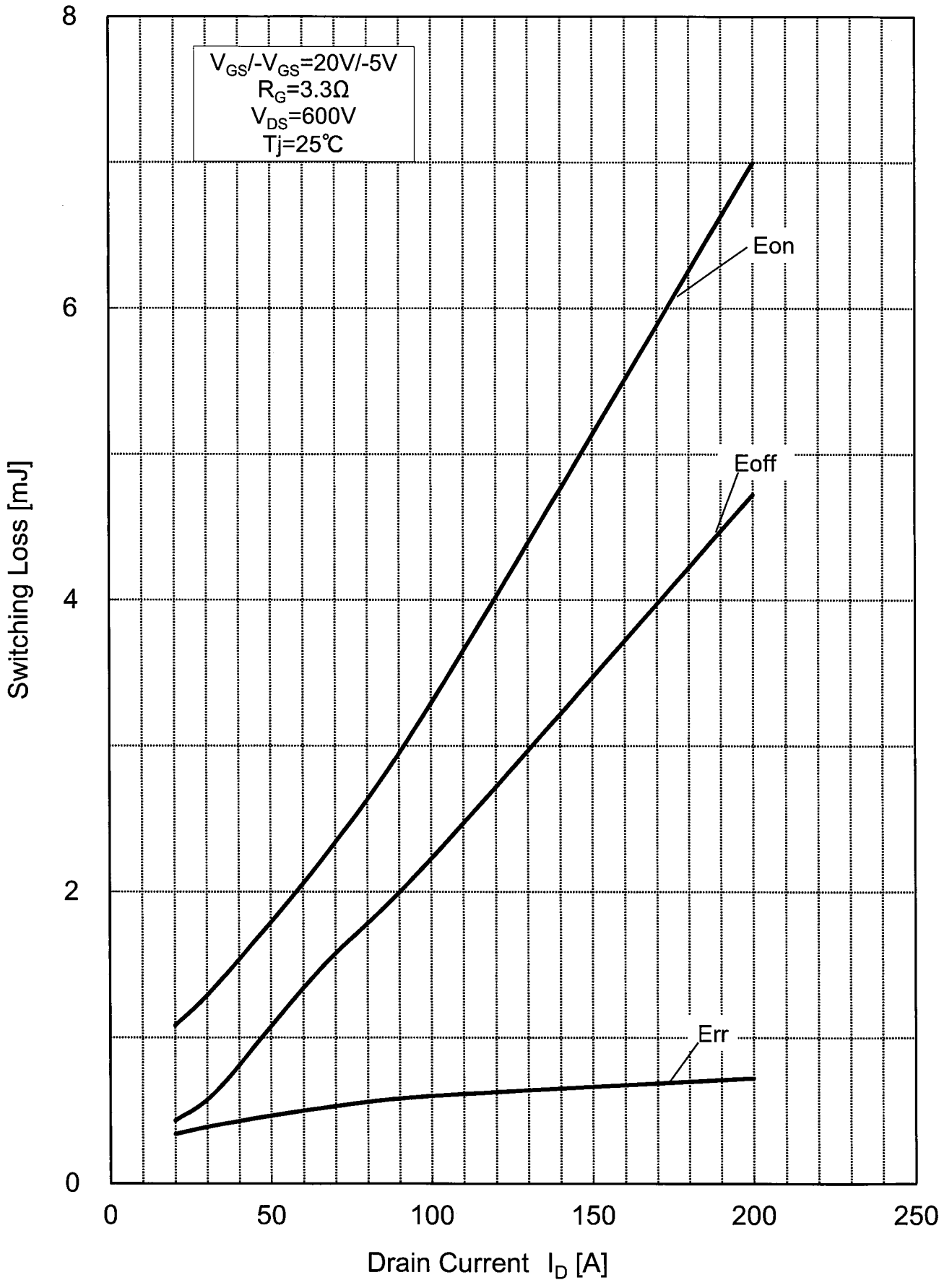


Fig.17 Switching Loss vs Drain Current (Typical)

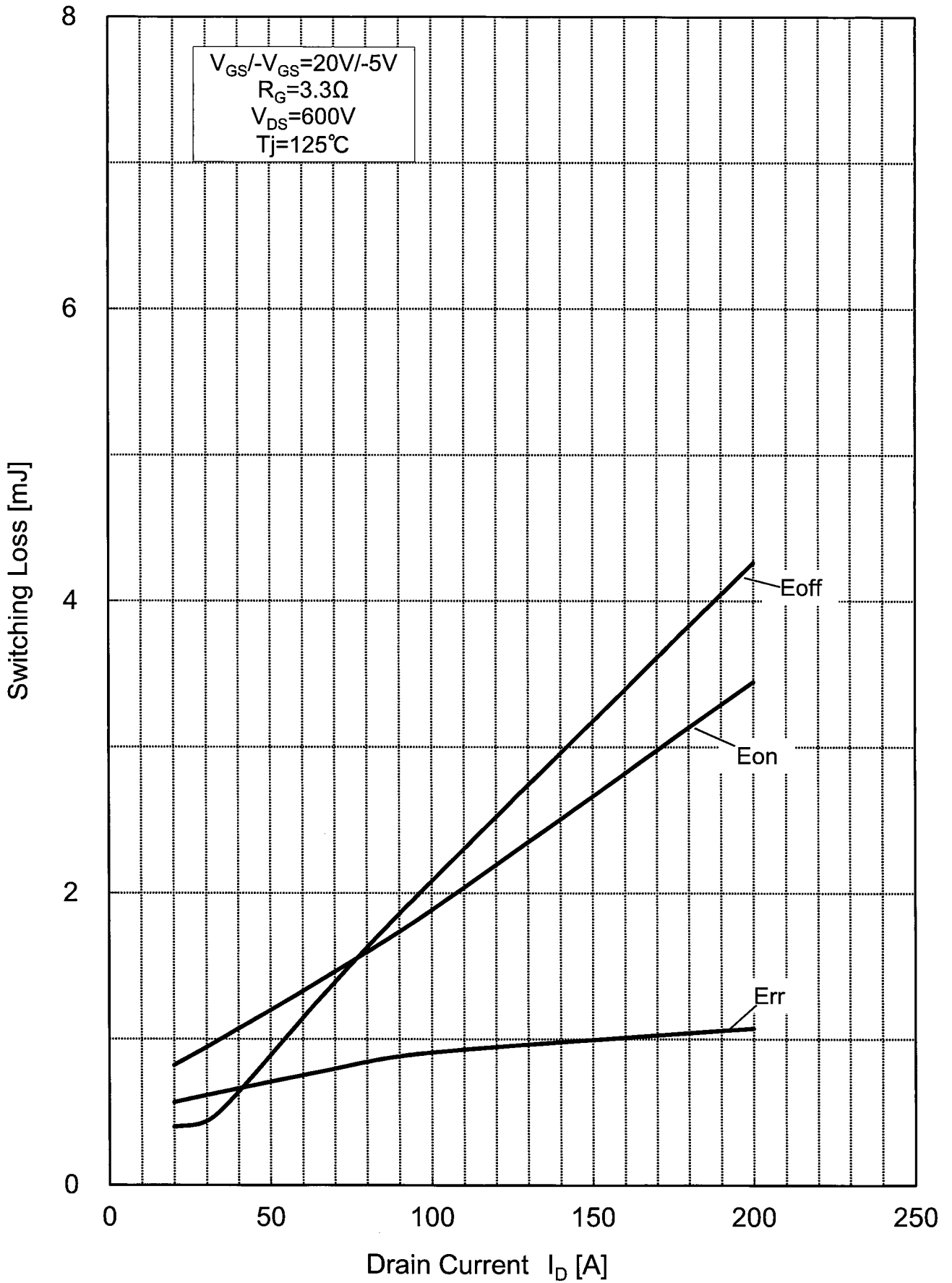
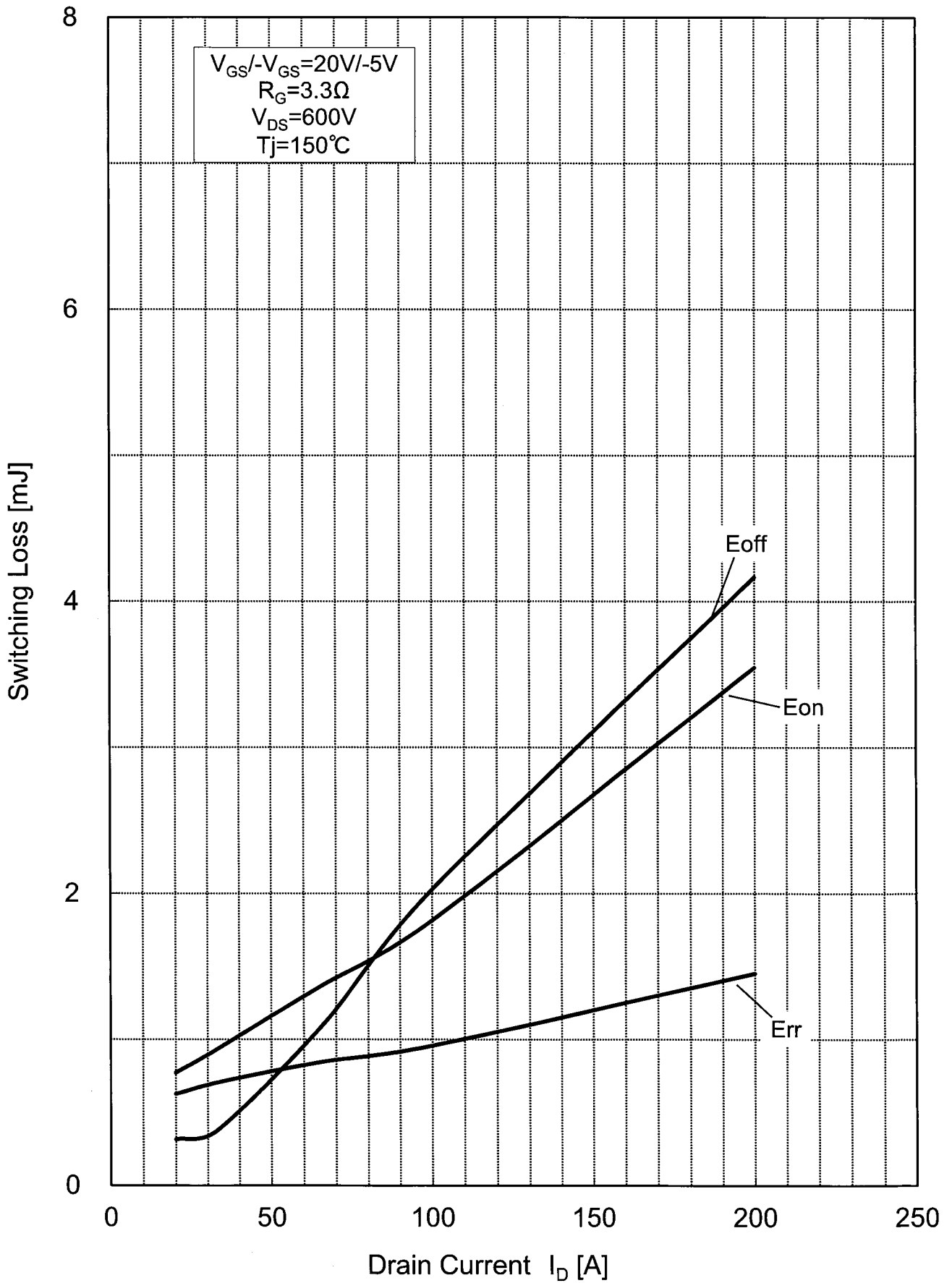
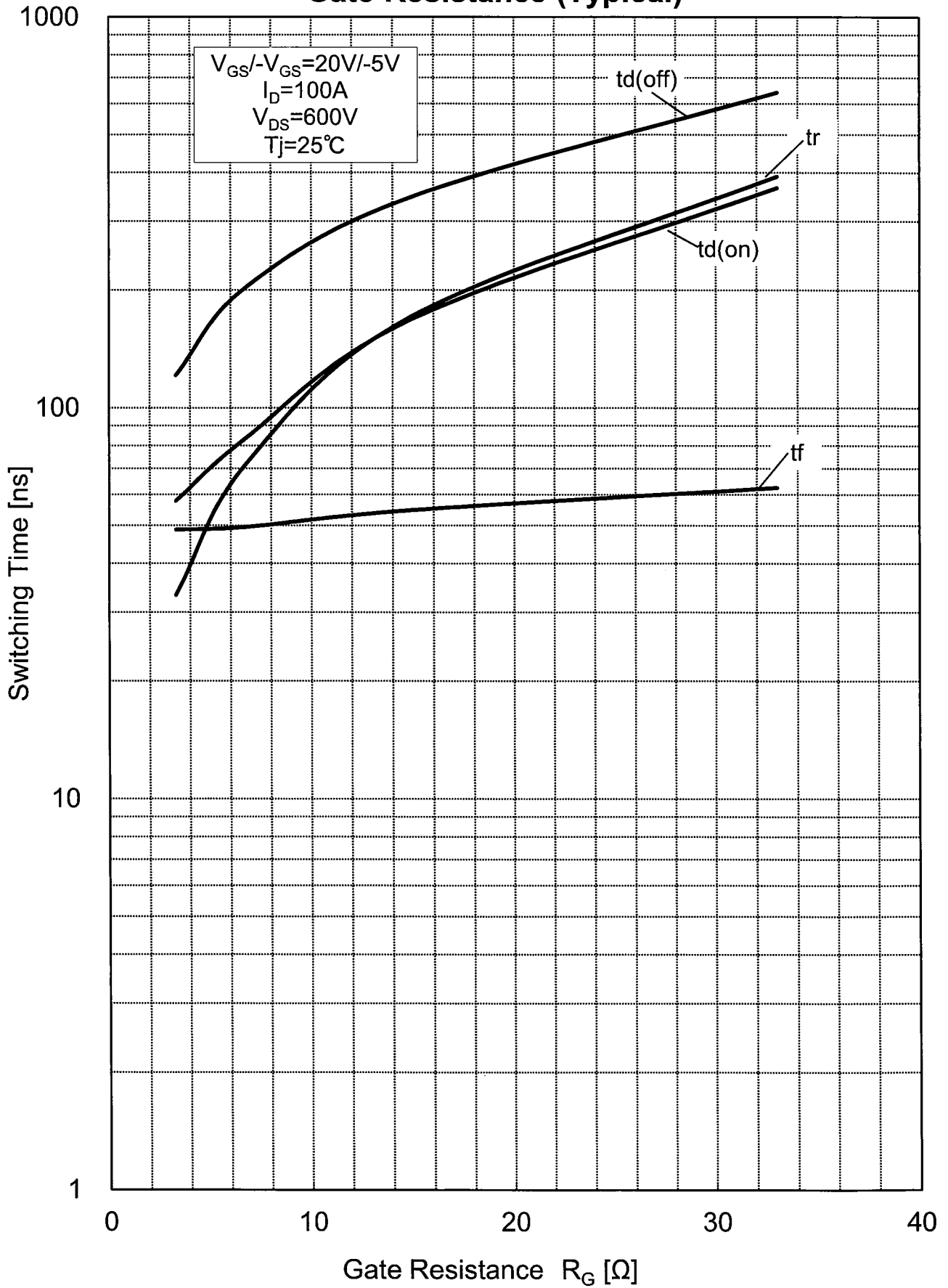


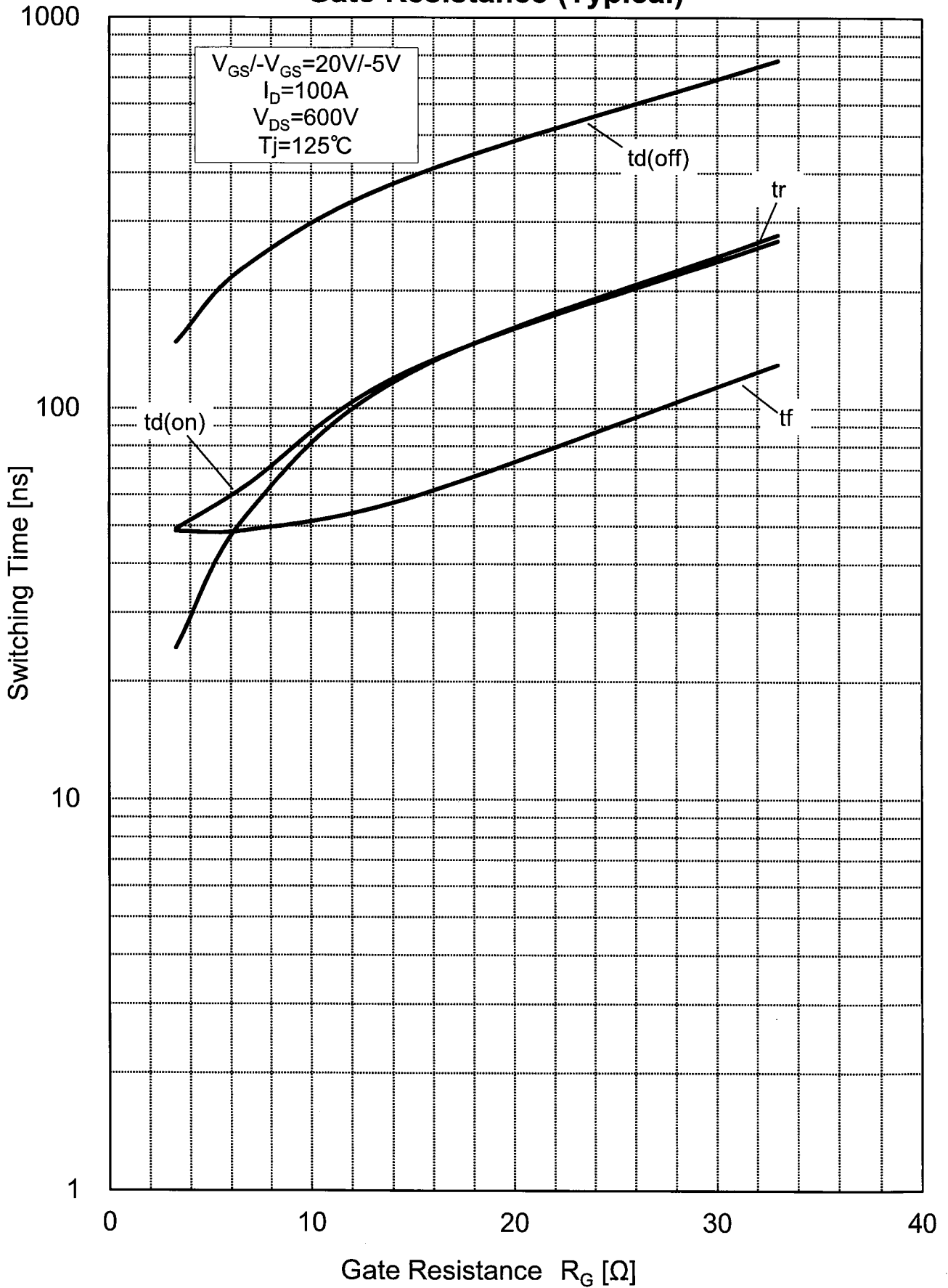
Fig.18 Switching Loss vs Drain Current (Typical)



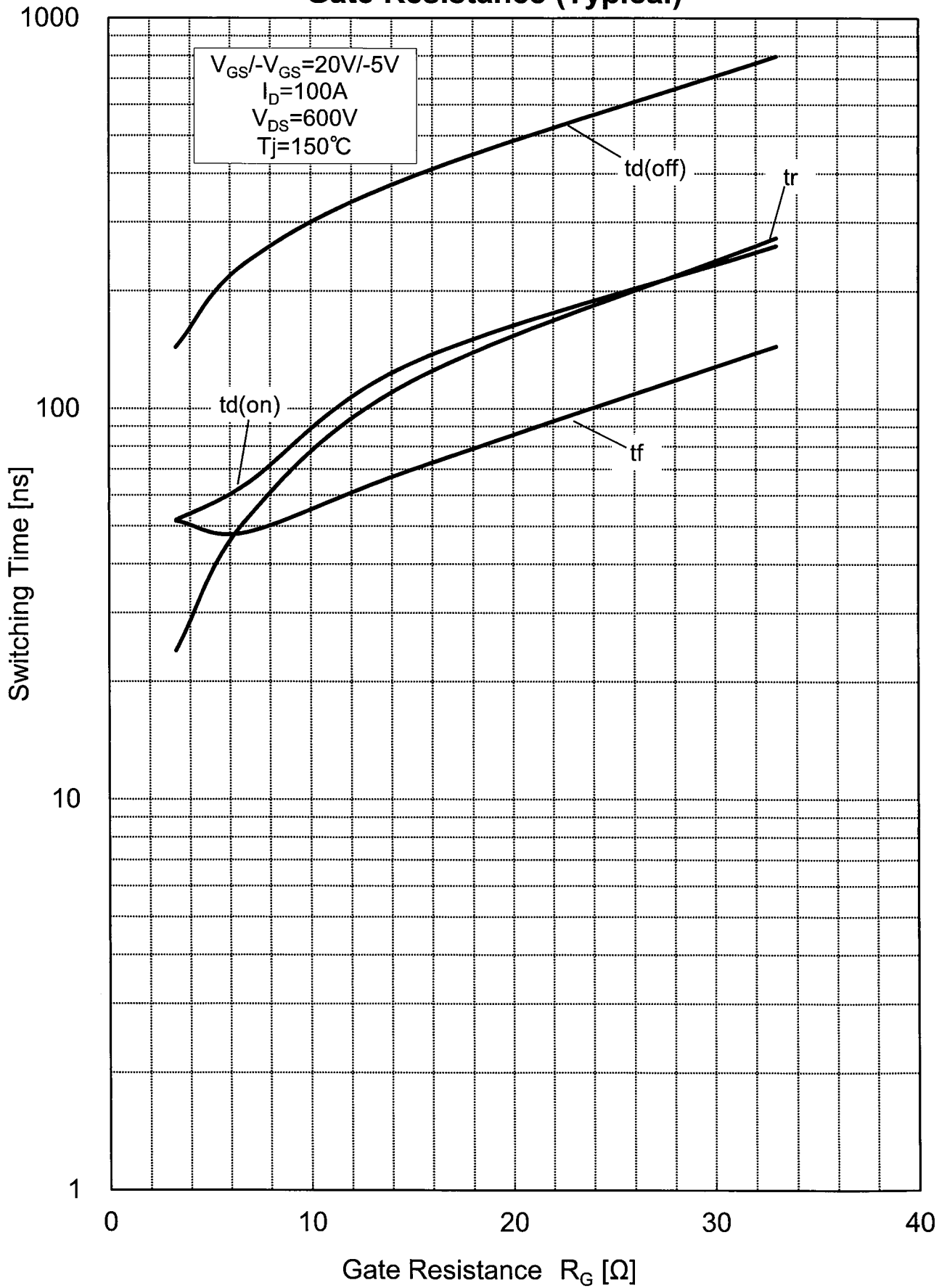
**Fig.19 Switching Time vs Gate Resistance (Typical)**



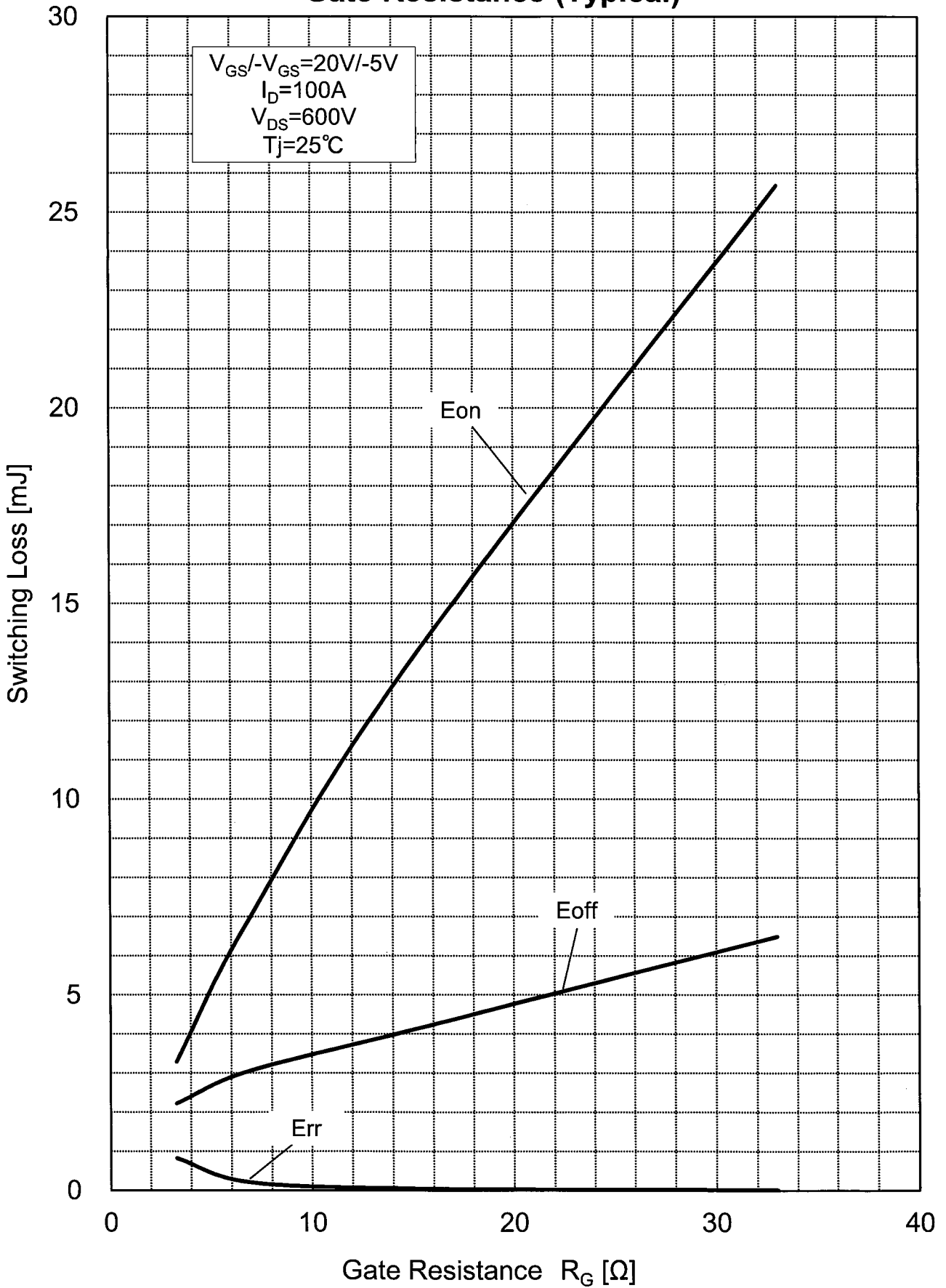
**Fig.20 Switching Time vs Gate Resistance (Typical)**



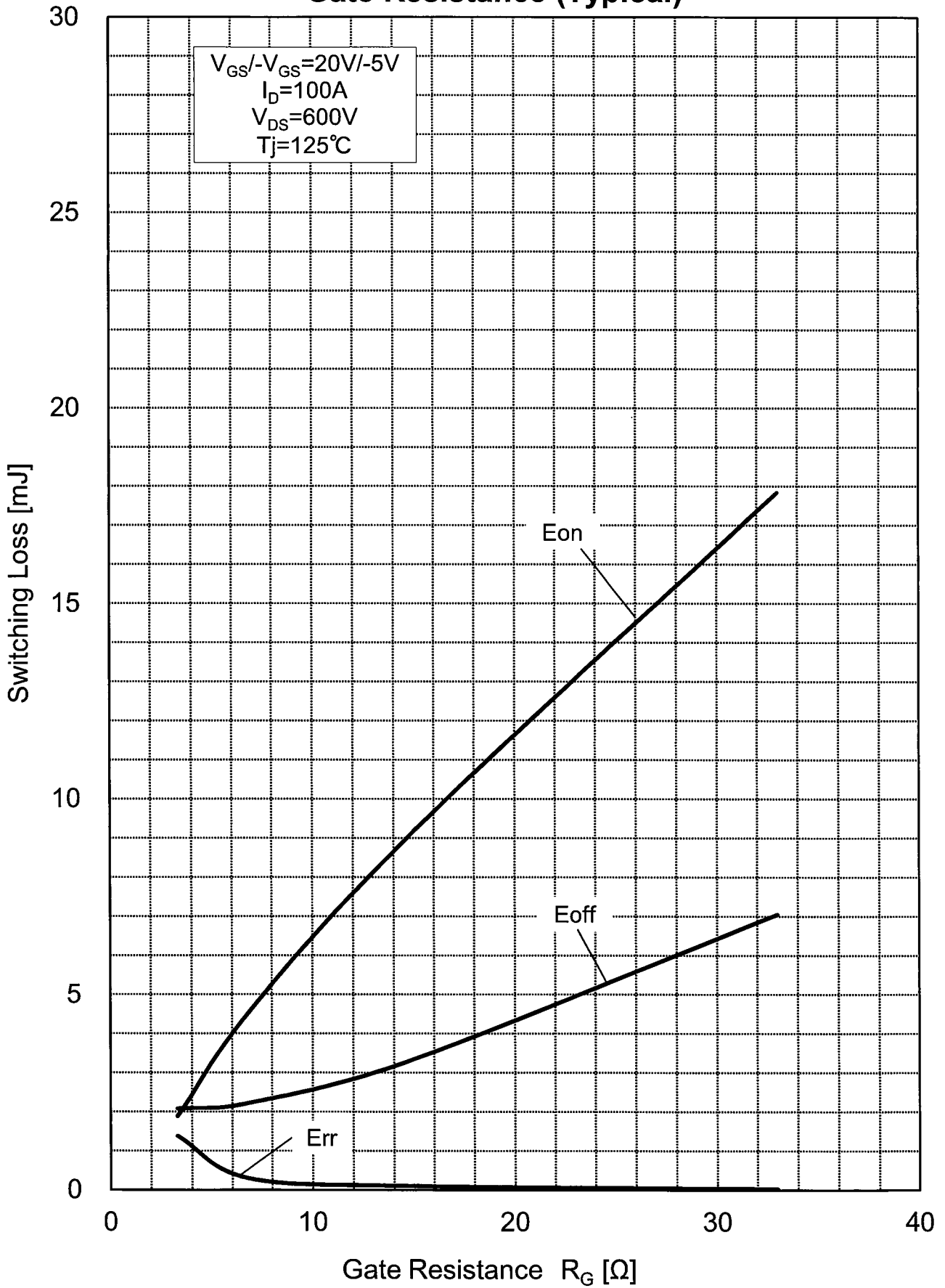
**Fig.21 Switching Time vs Gate Resistance (Typical)**



**Fig.22 Switching Loss vs Gate Resistance (Typical)**

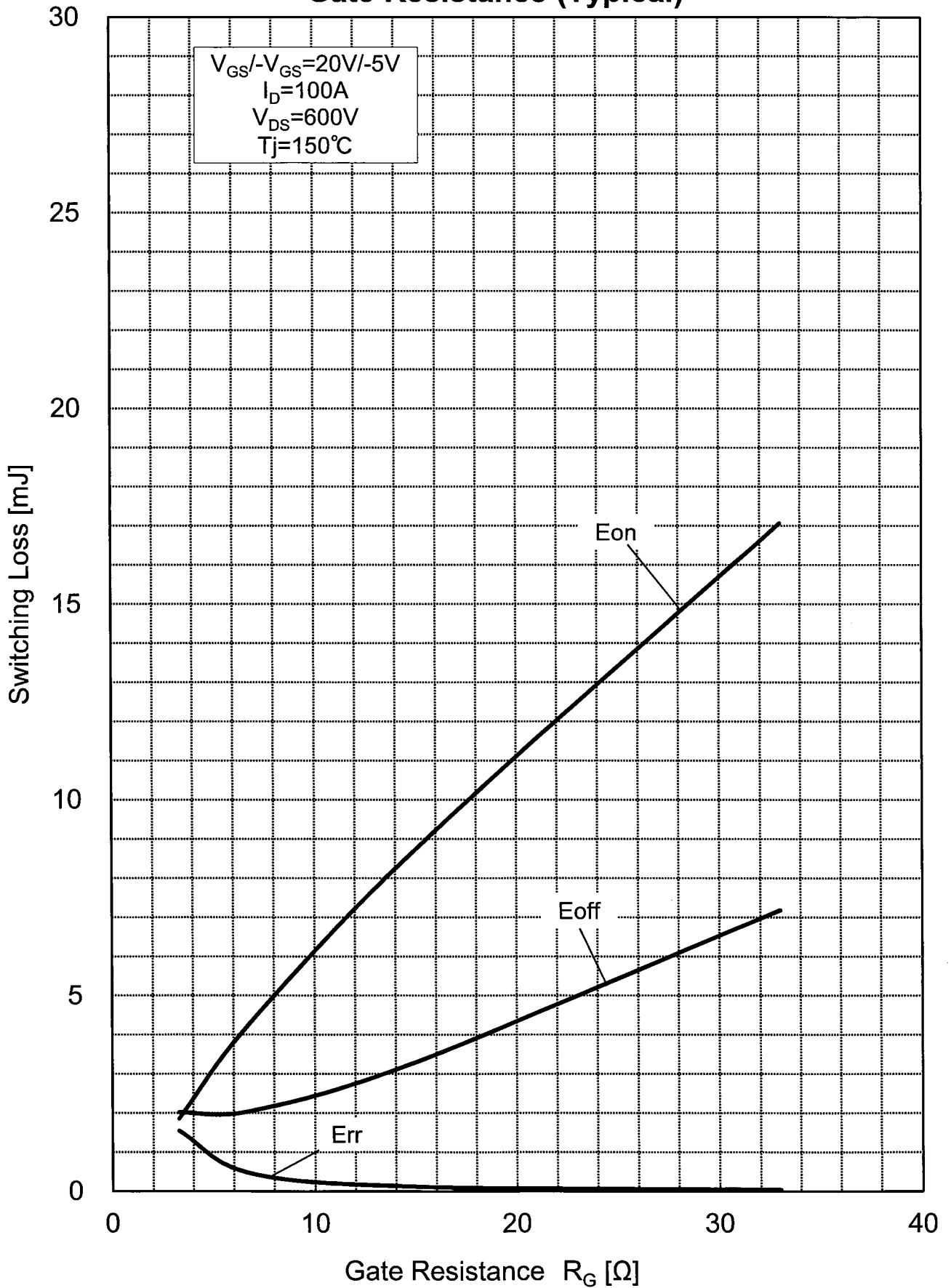


**Fig.23 Switching Loss vs Gate Resistance (Typical)**

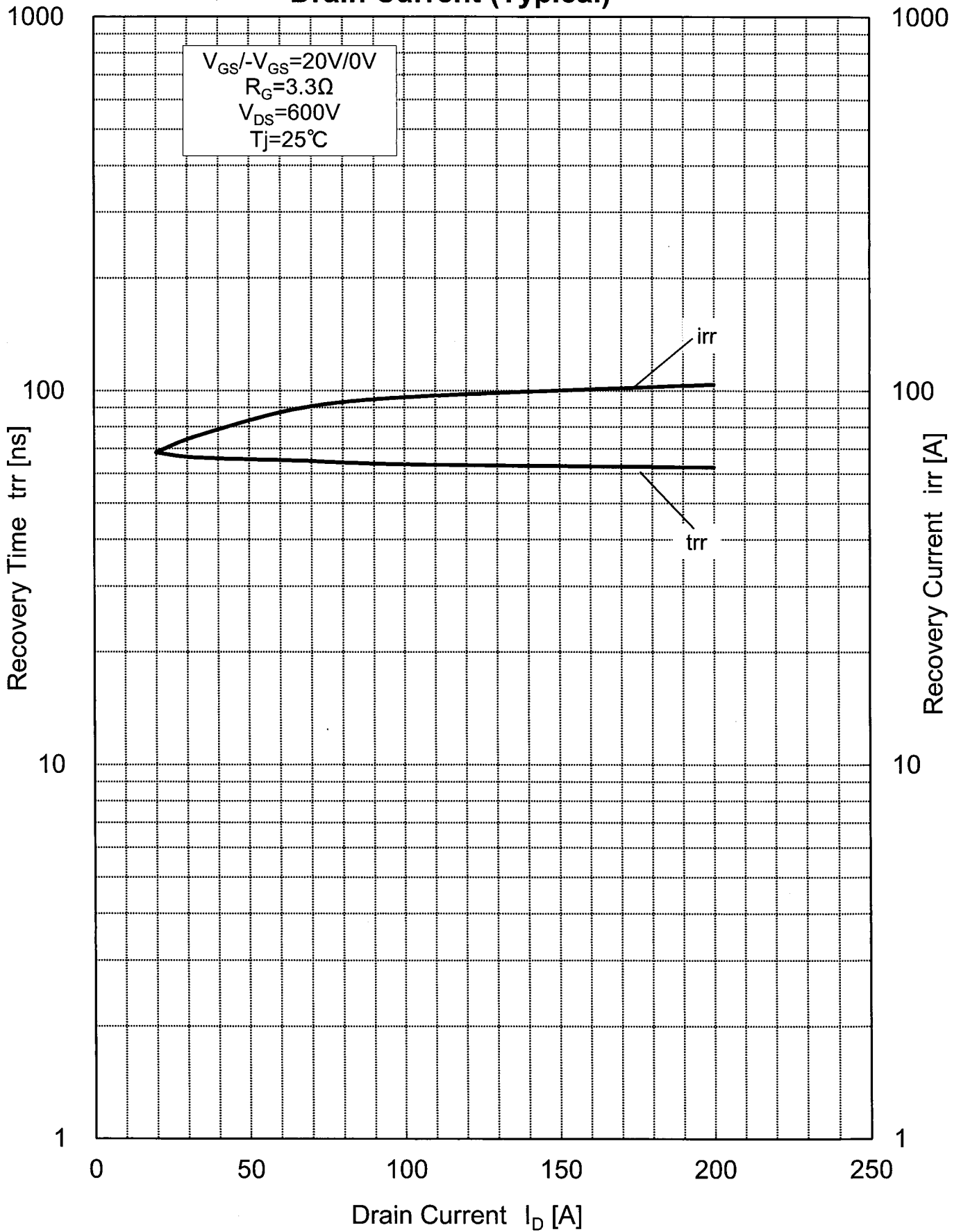




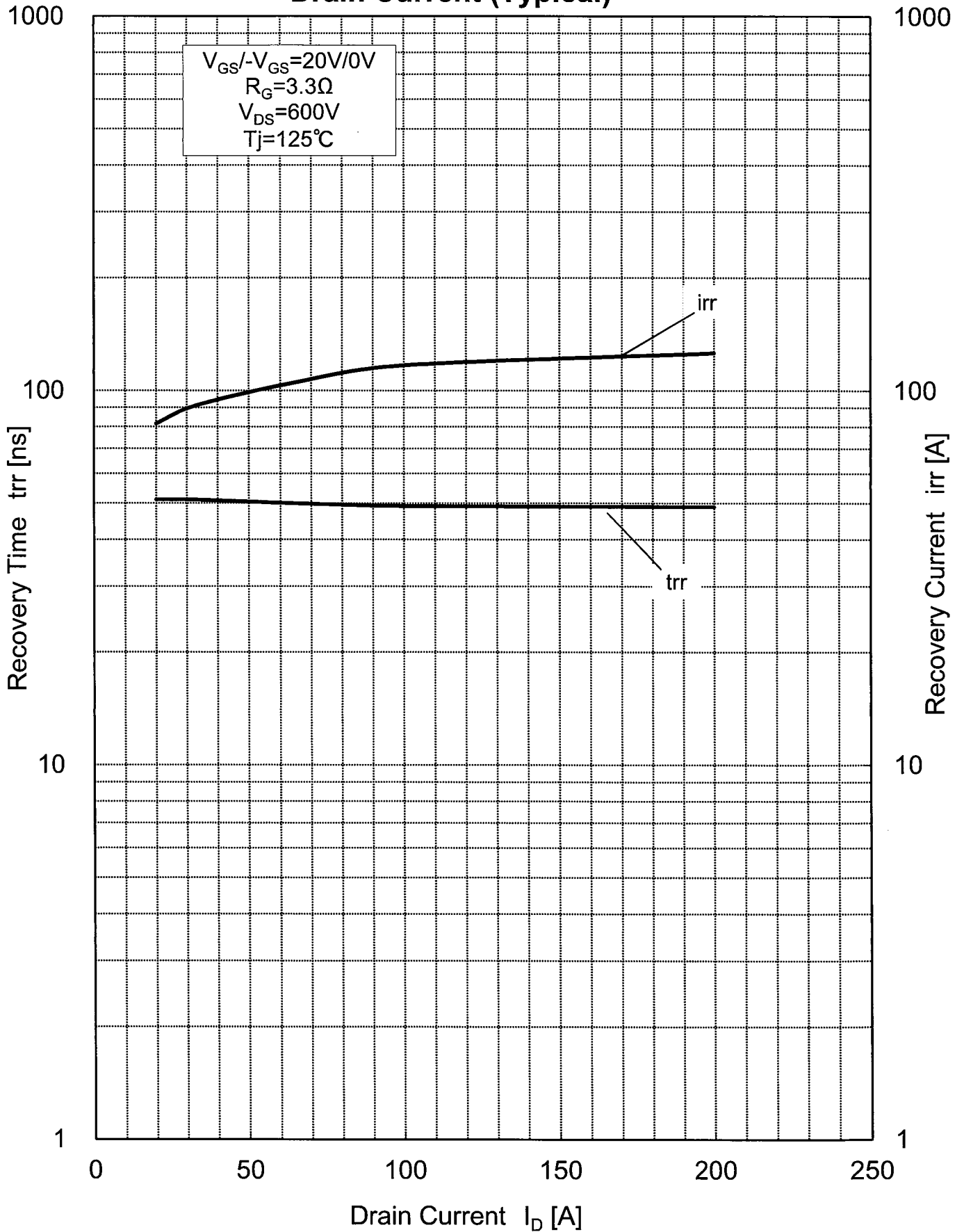
**Fig.24 Switching Loss vs Gate Resistance (Typical)**



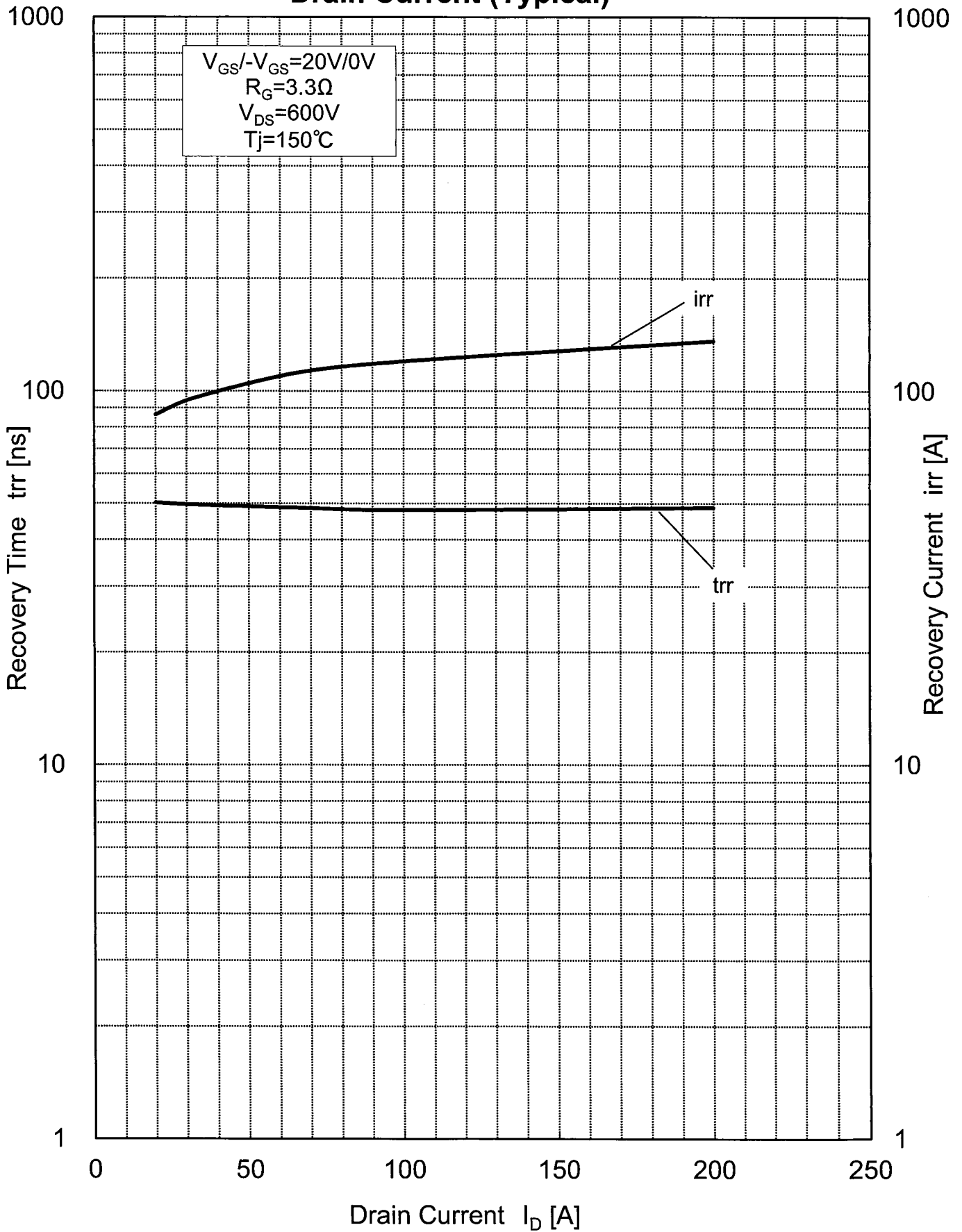
**Fig.25 Recovery Characteristics vs Drain Current (Typical)**



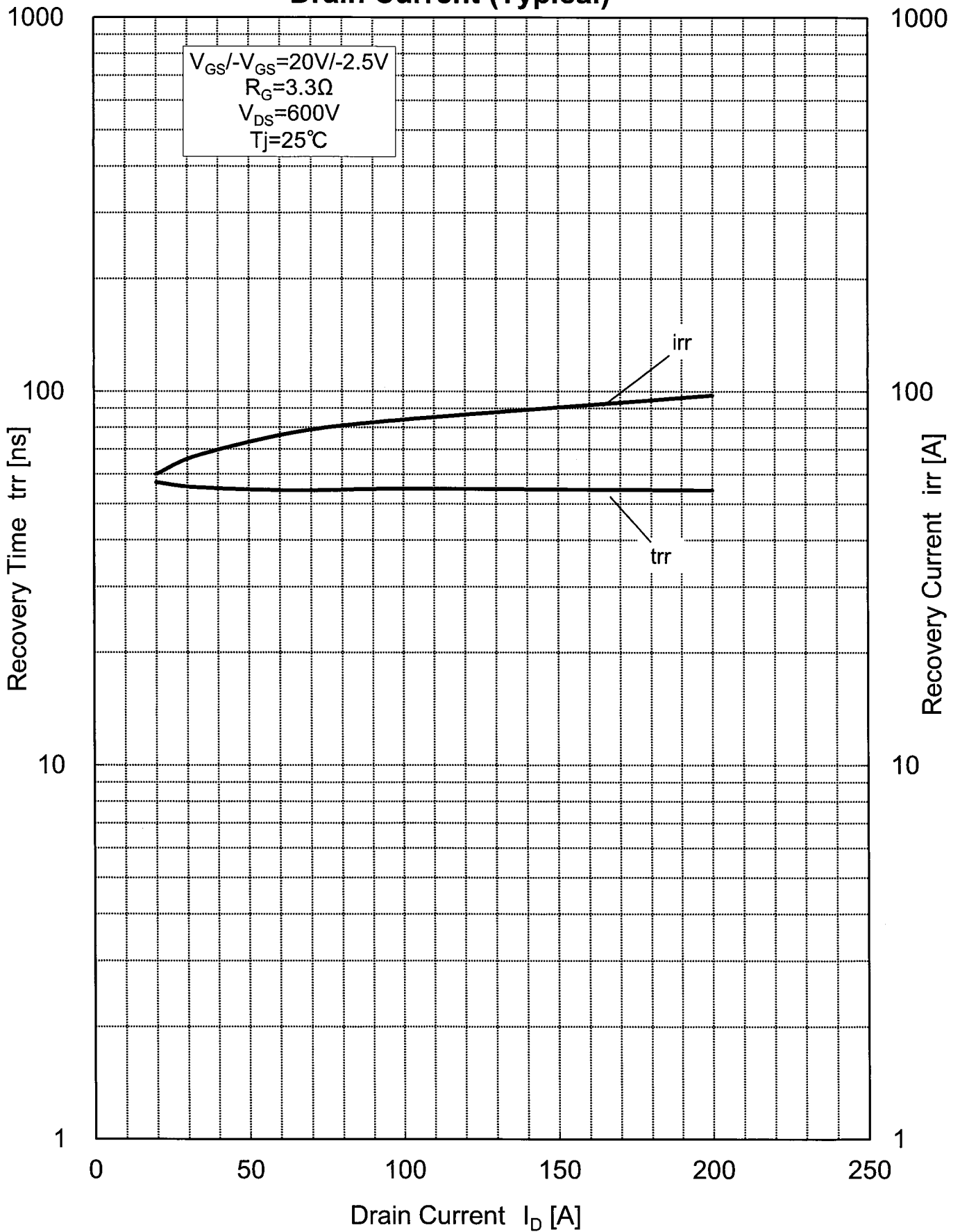
**Fig.26 Recovery Characteristics vs Drain Current (Typical)**



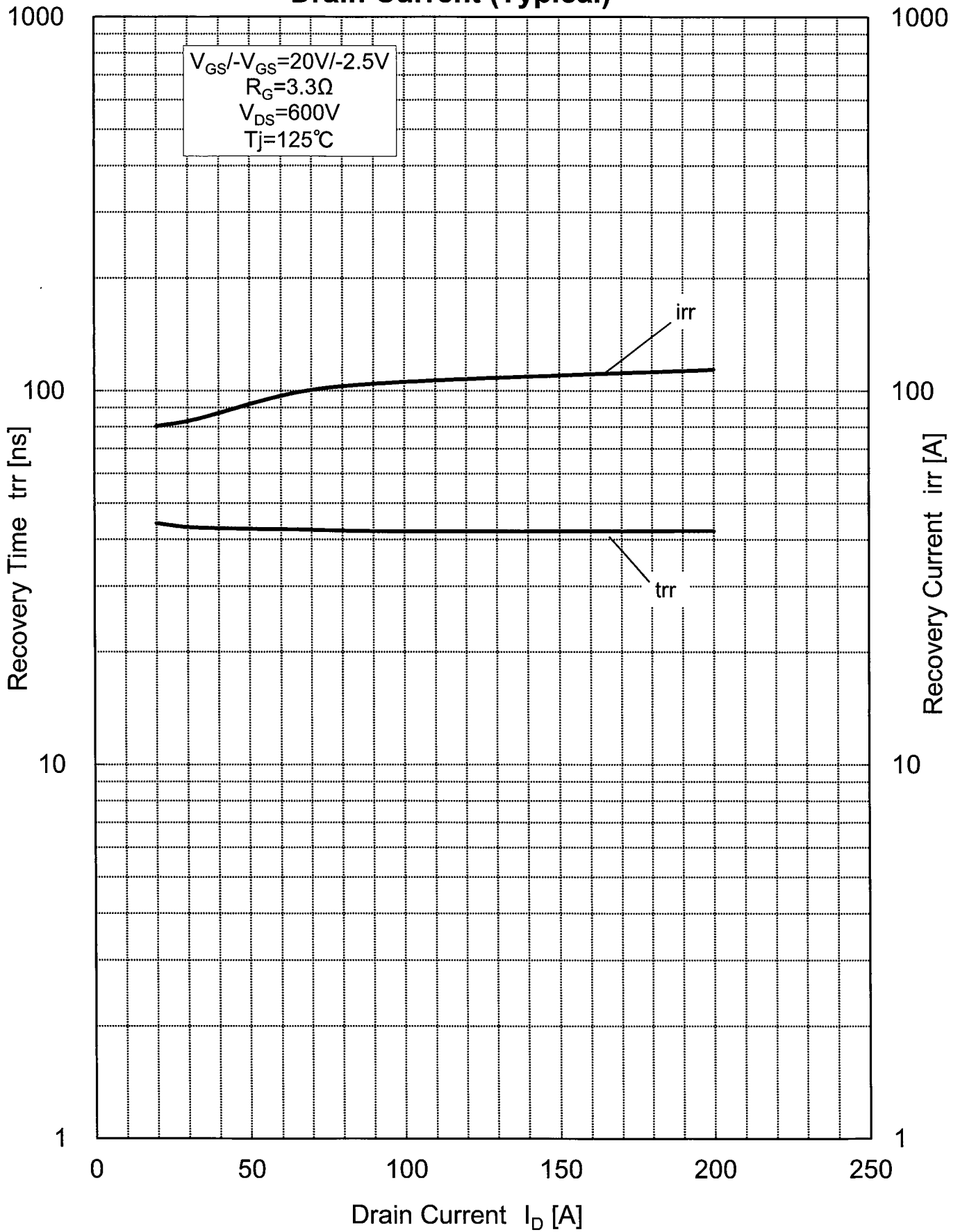
**Fig.27 Recovery Characteristics vs Drain Current (Typical)**



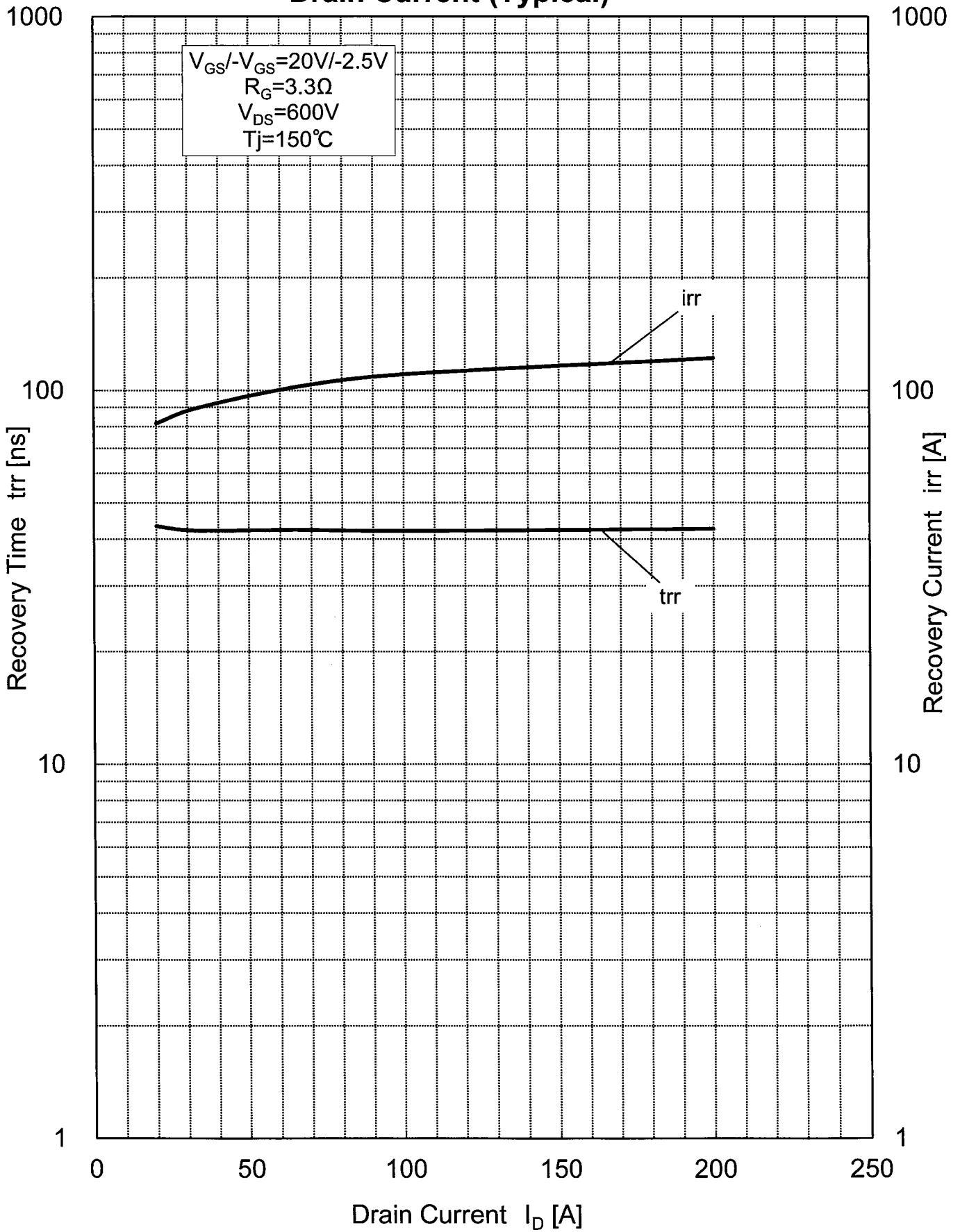
**Fig.28 Recovery Characteristics vs  
Drain Current (Typical)**



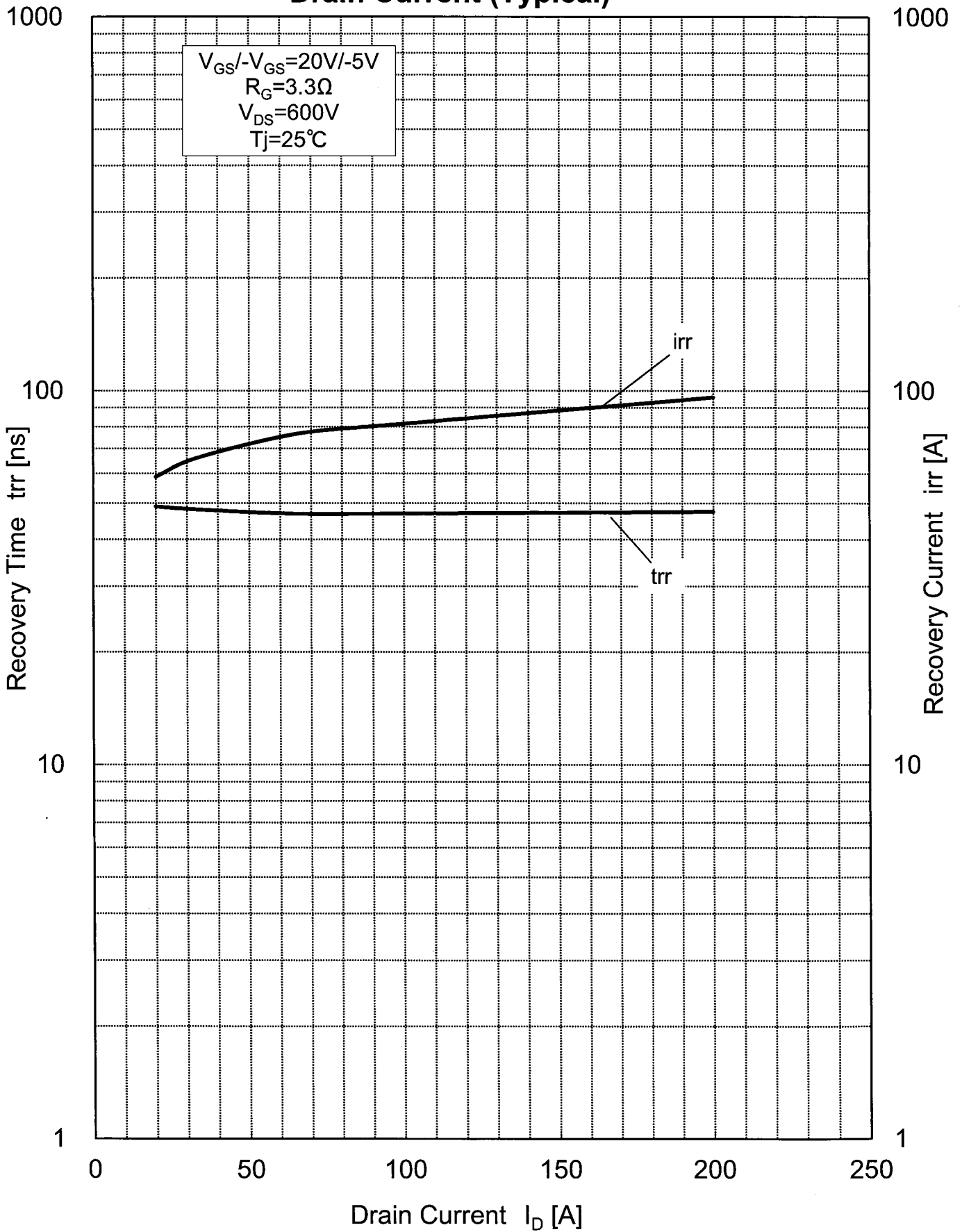
**Fig.29 Recovery Characteristics vs Drain Current (Typical)**



**Fig.30 Recovery Characteristics vs Drain Current (Typical)**

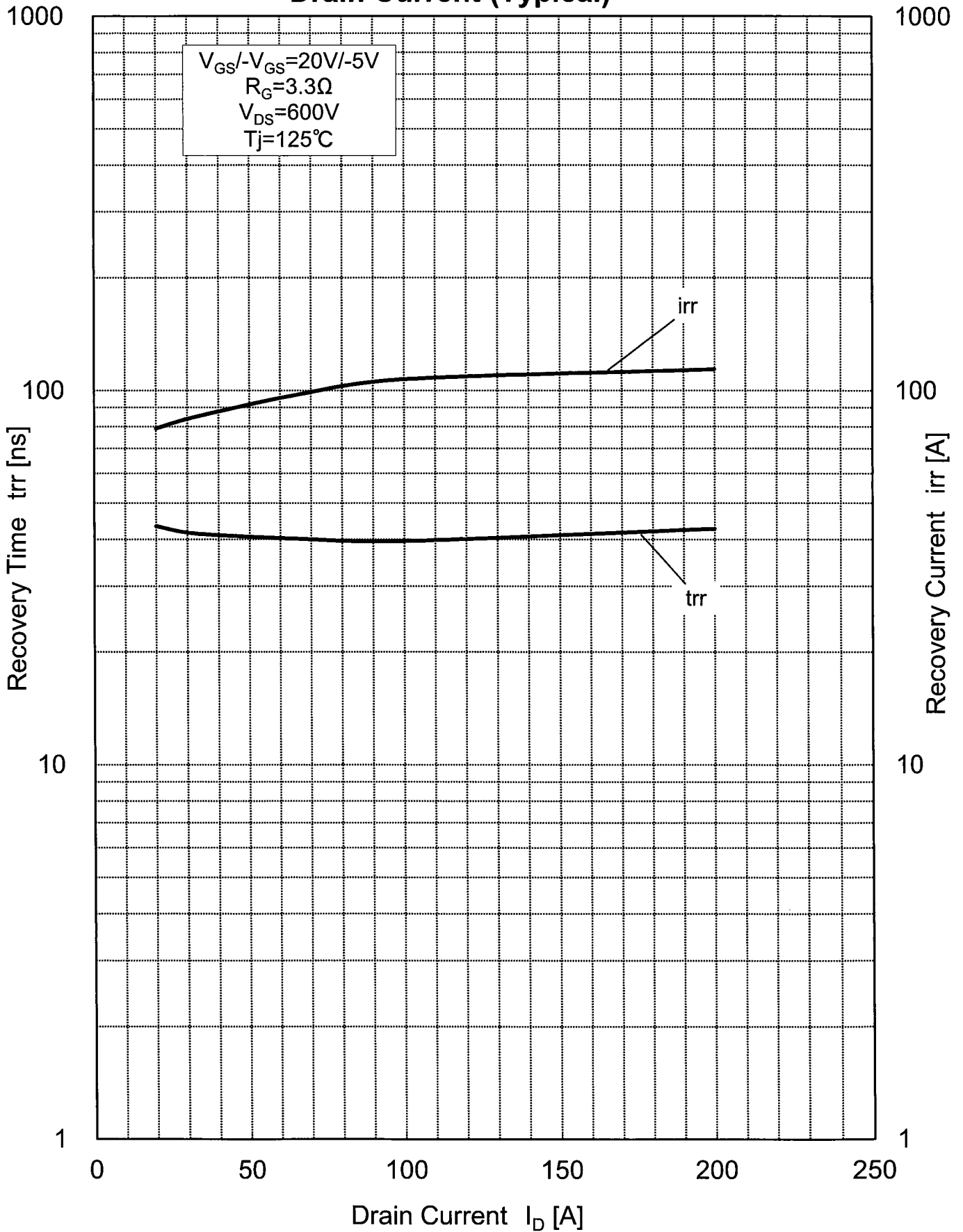


**Fig.31 Recovery Characteristics vs Drain Current (Typical)**

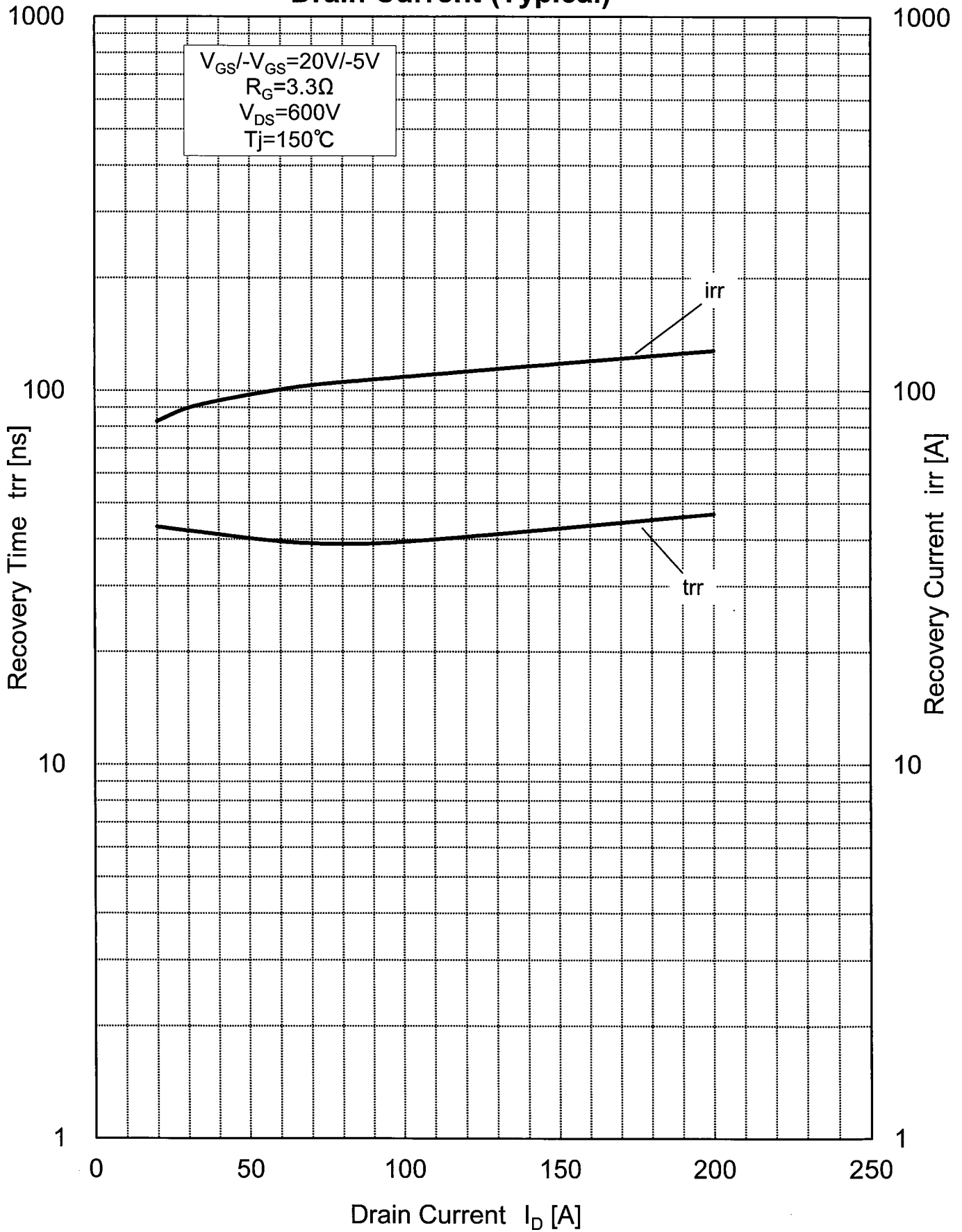




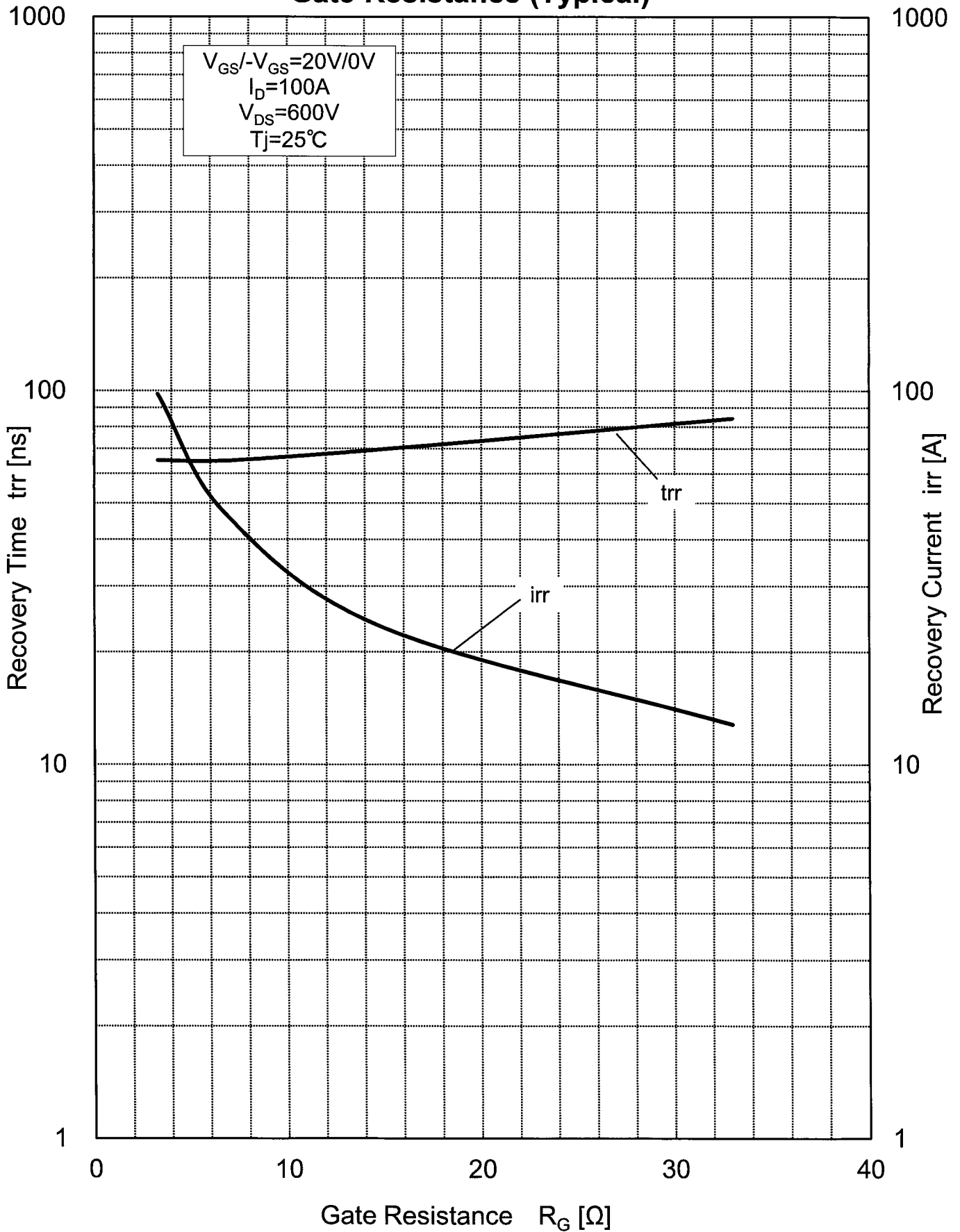
**Fig.32 Recovery Characteristics vs  
Drain Current (Typical)**



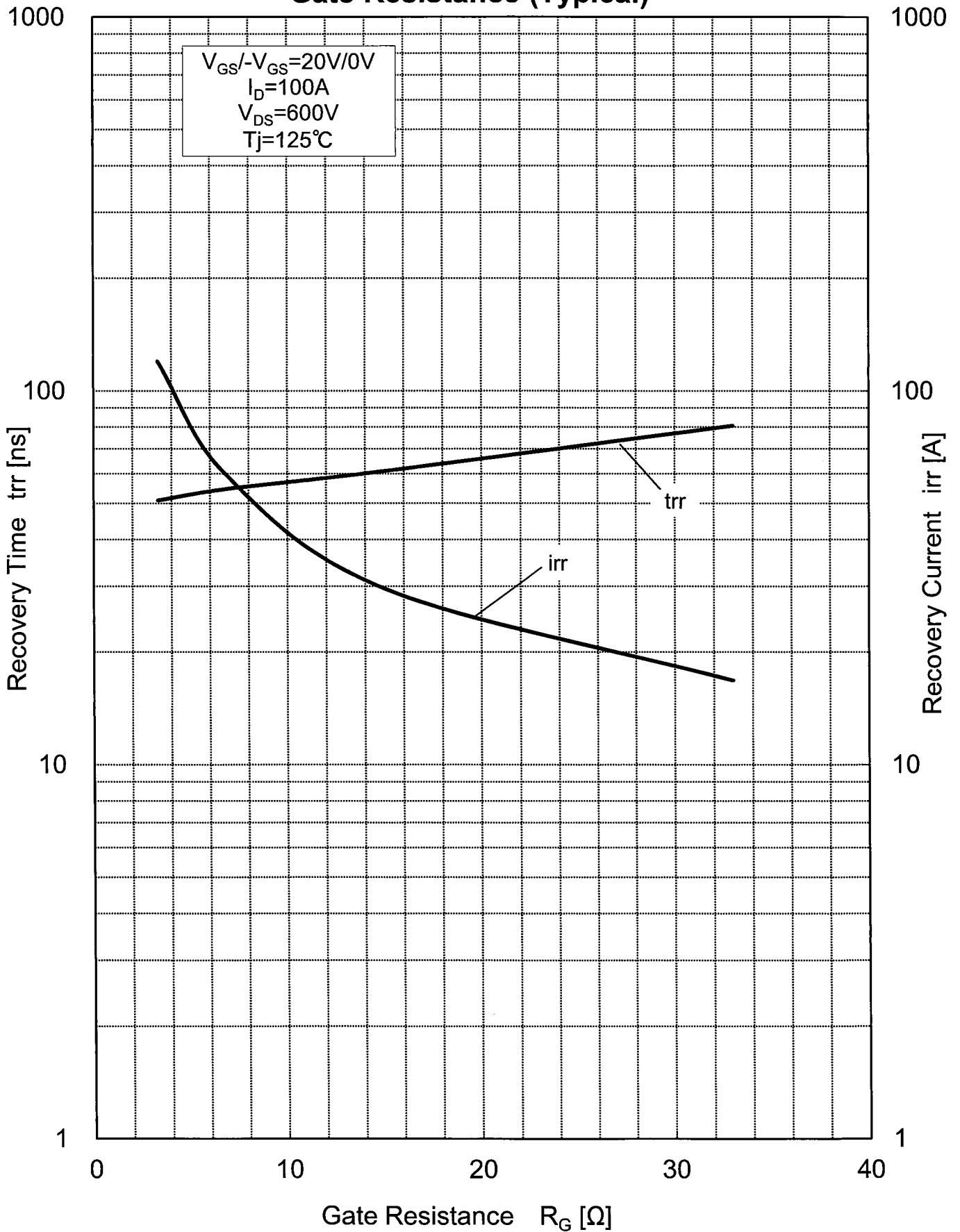
**Fig.33 Recovery Characteristics vs Drain Current (Typical)**



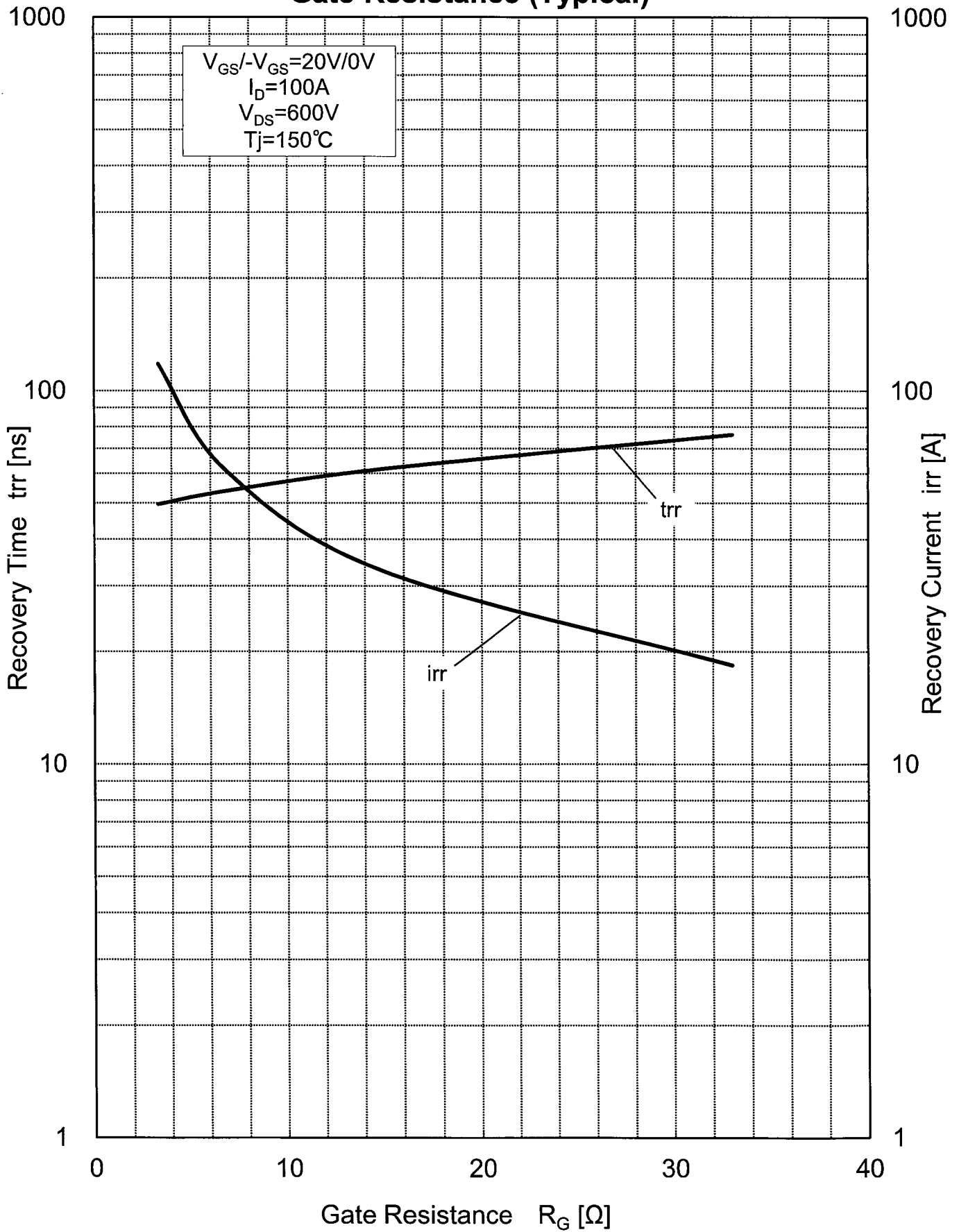
**Fig.34 Recovery Characteristics vs Gate Resistance (Typical)**



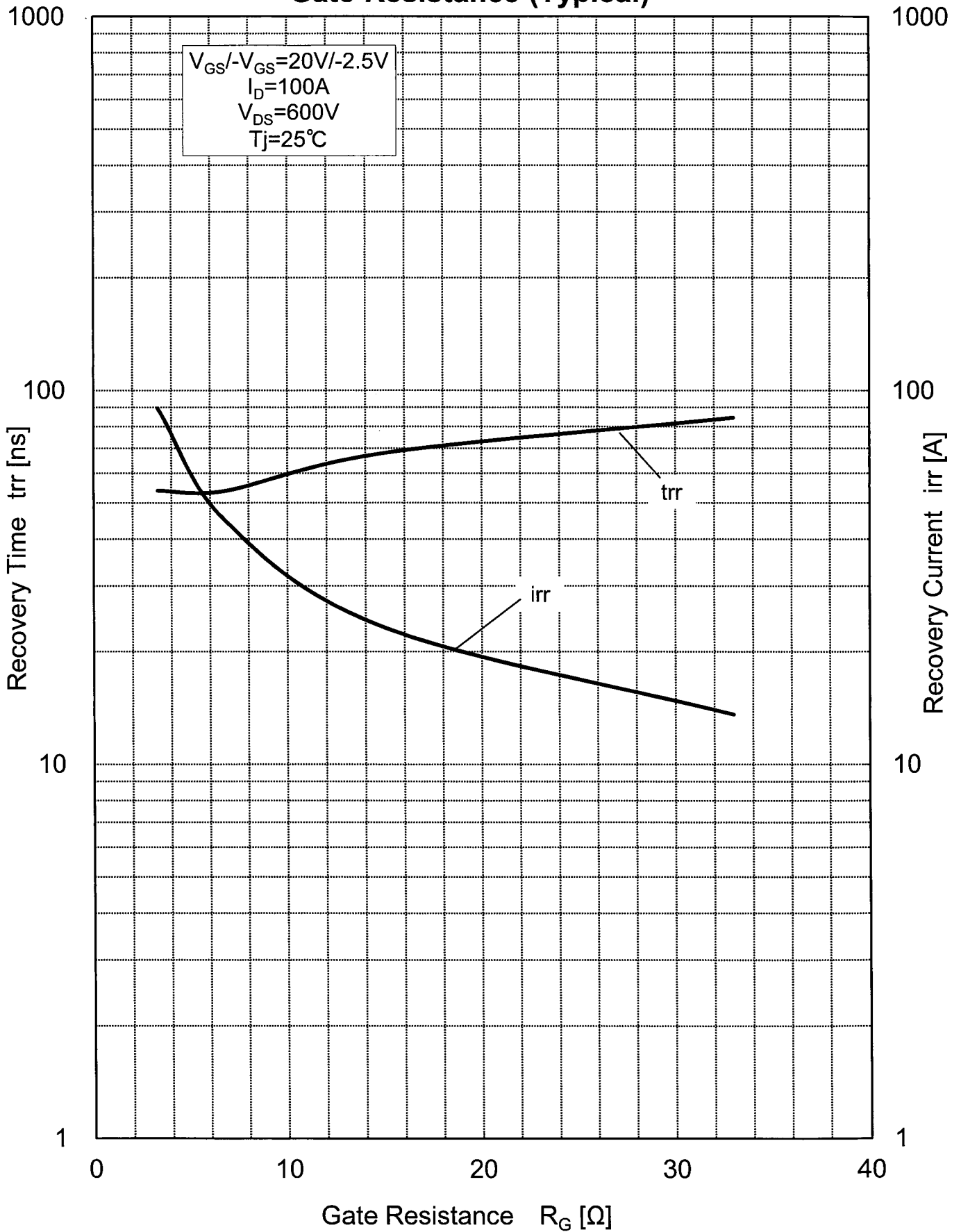
**Fig.35 Recovery Characteristics vs Gate Resistance (Typical)**



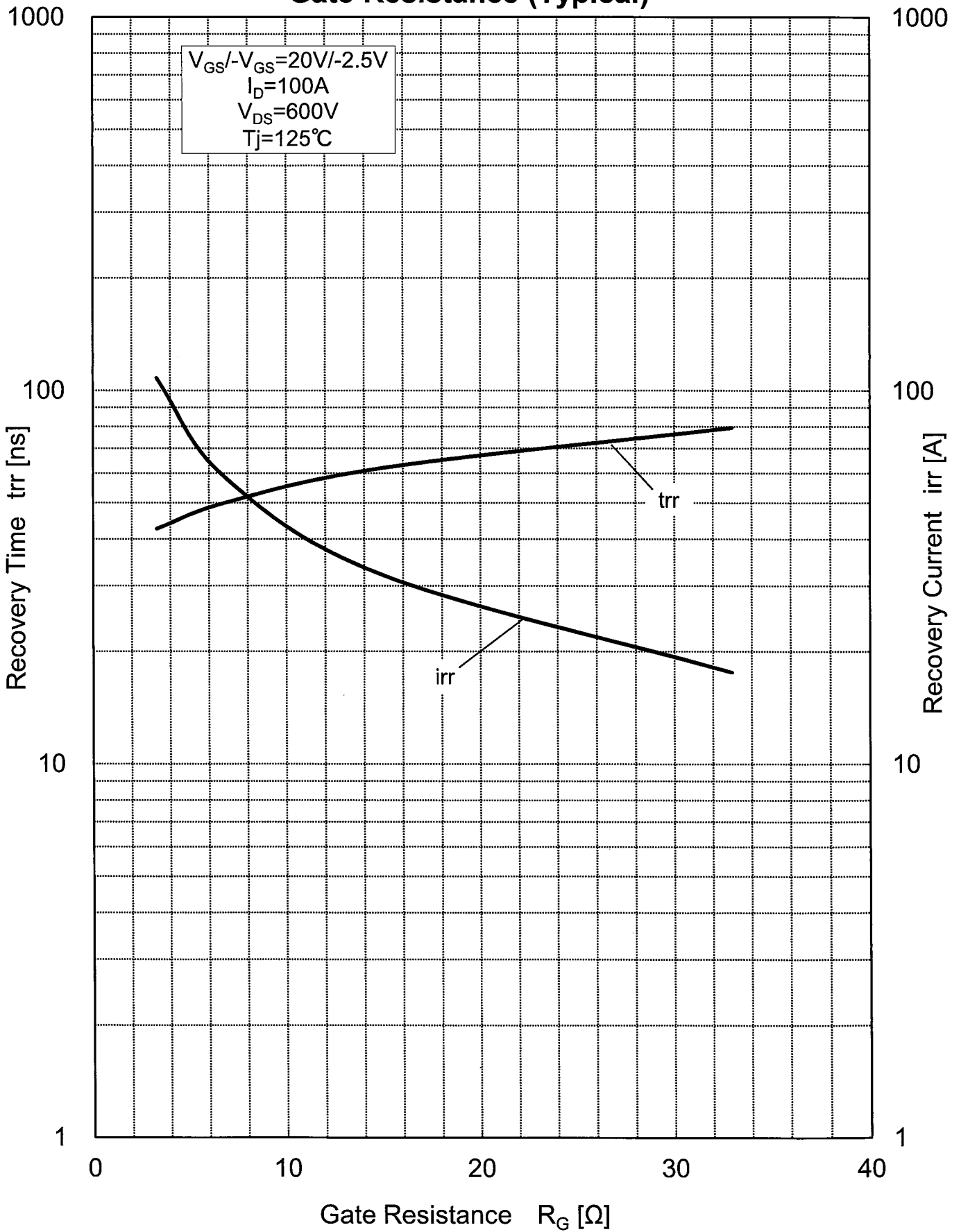
**Fig.36 Recovery Characteristics vs Gate Resistance (Typical)**



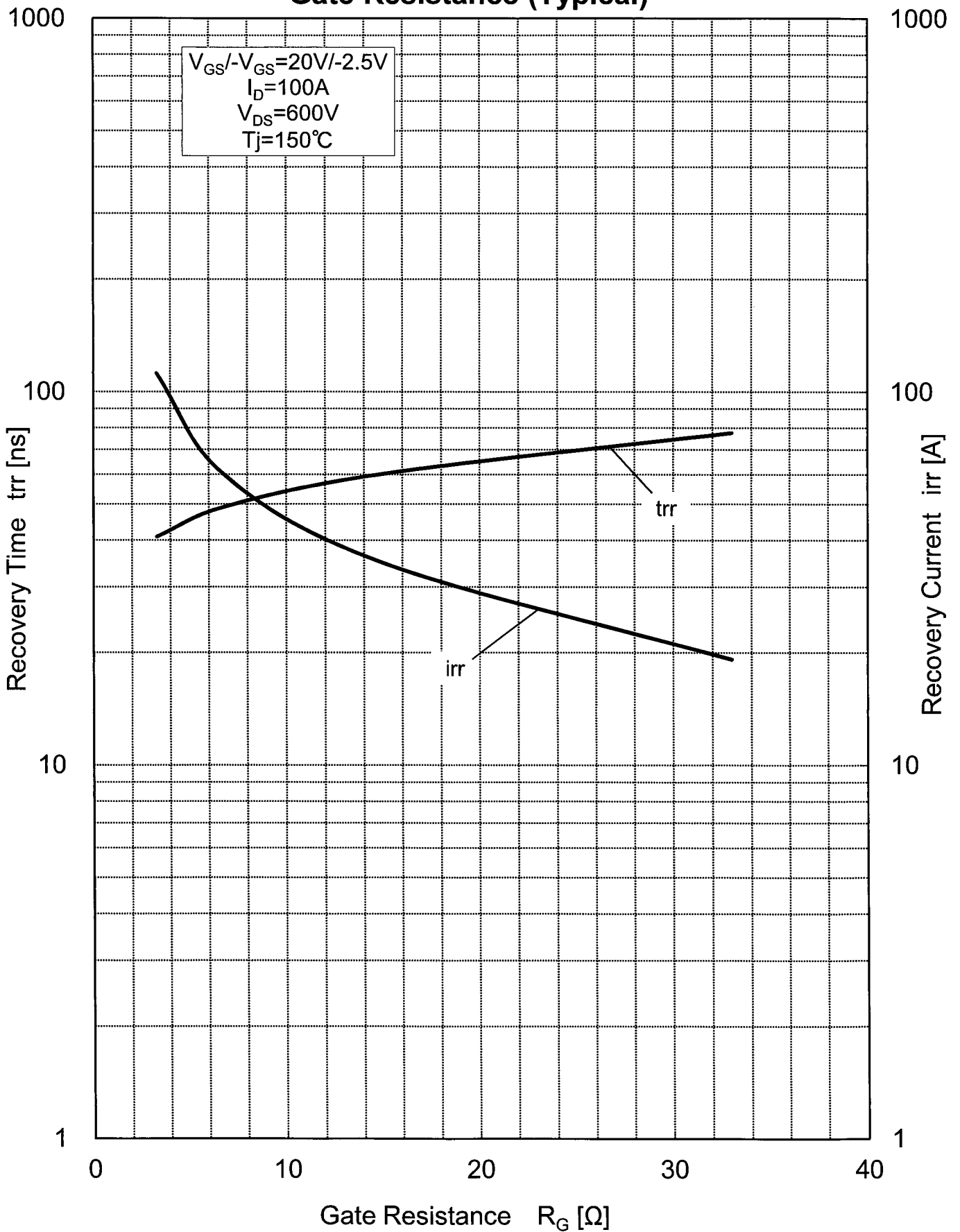
**Fig.37 Recovery Characteristics vs Gate Resistance (Typical)**



**Fig.38 Recovery Characteristics vs Gate Resistance (Typical)**

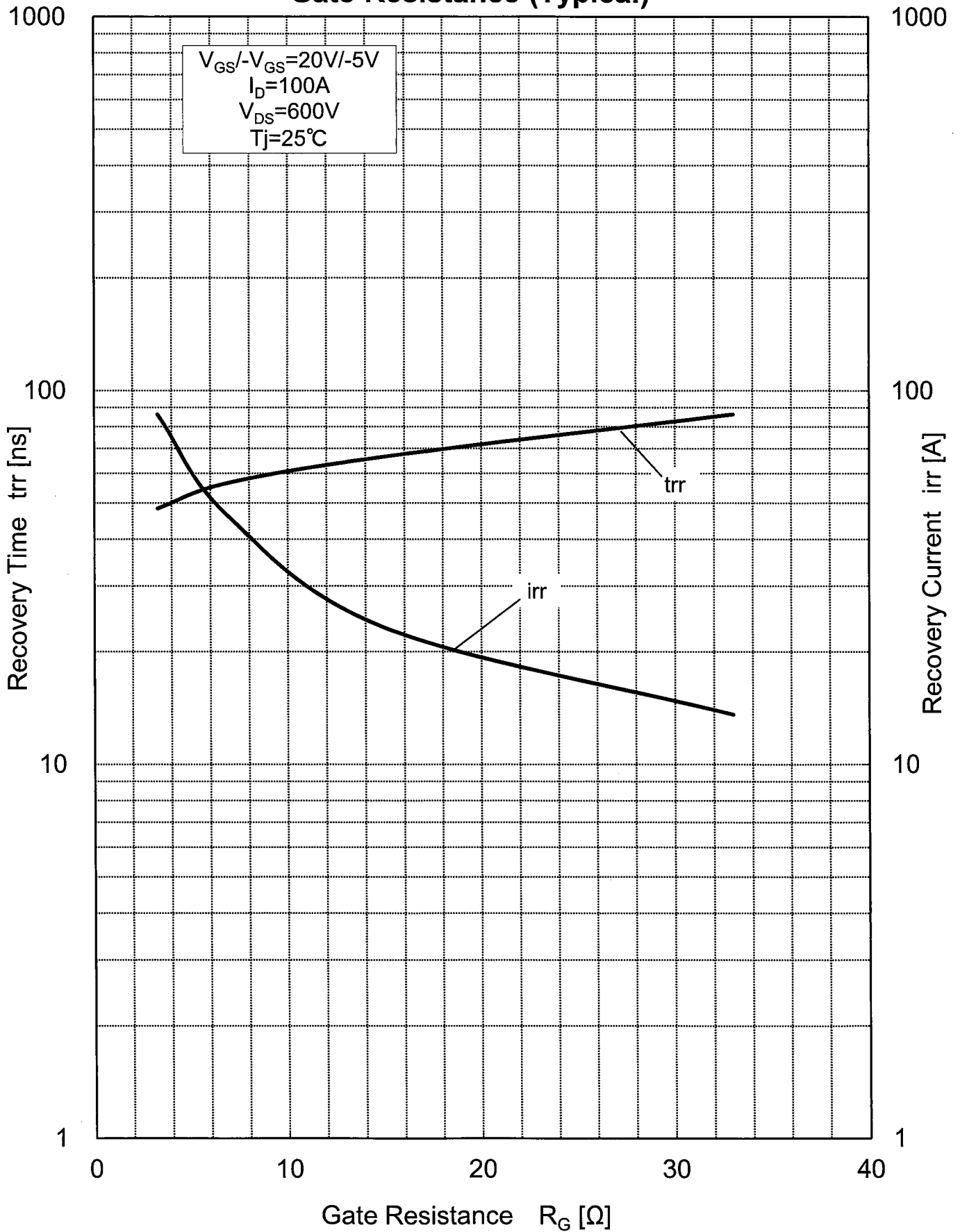


**Fig.39 Recovery Characteristics vs Gate Resistance (Typical)**

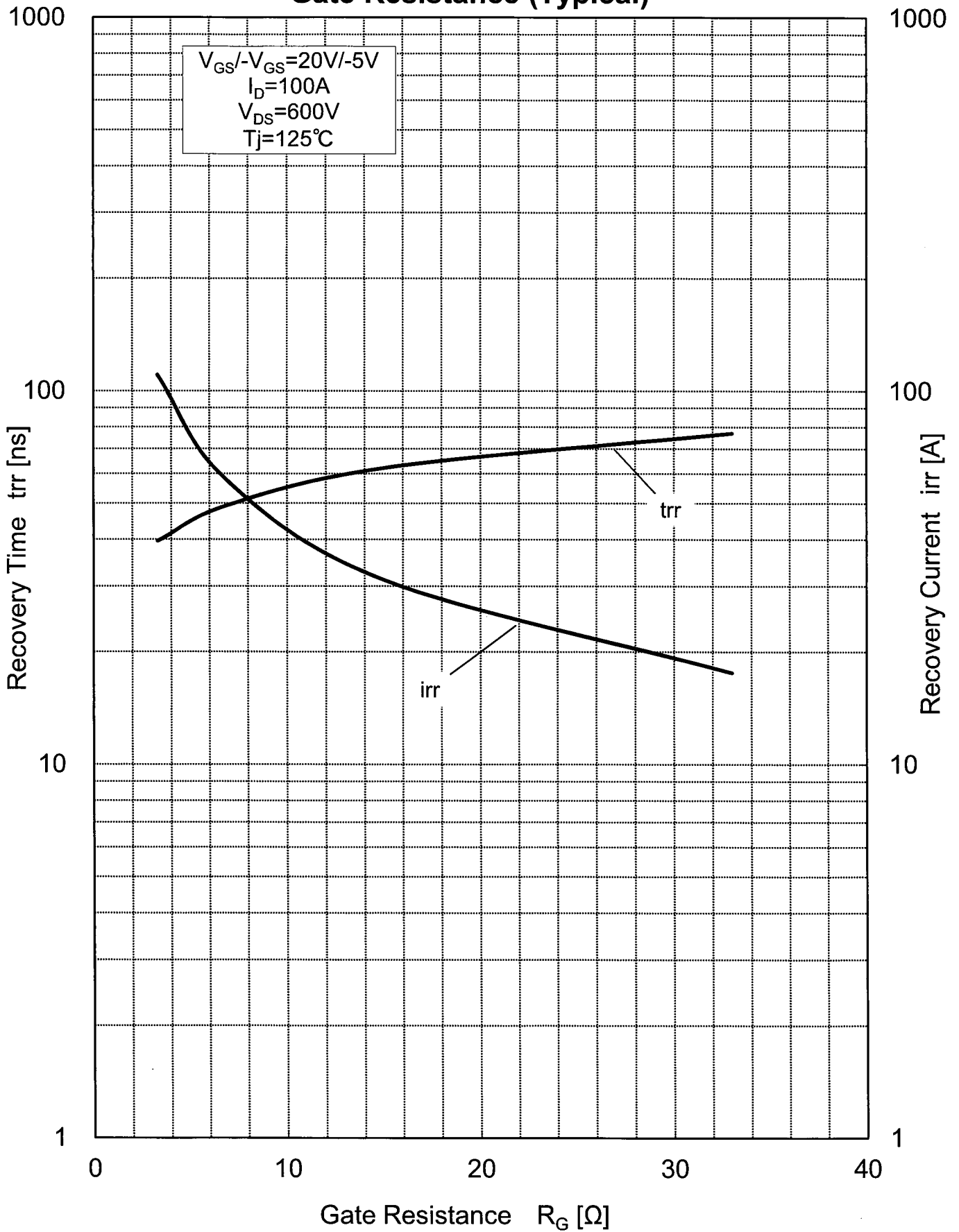




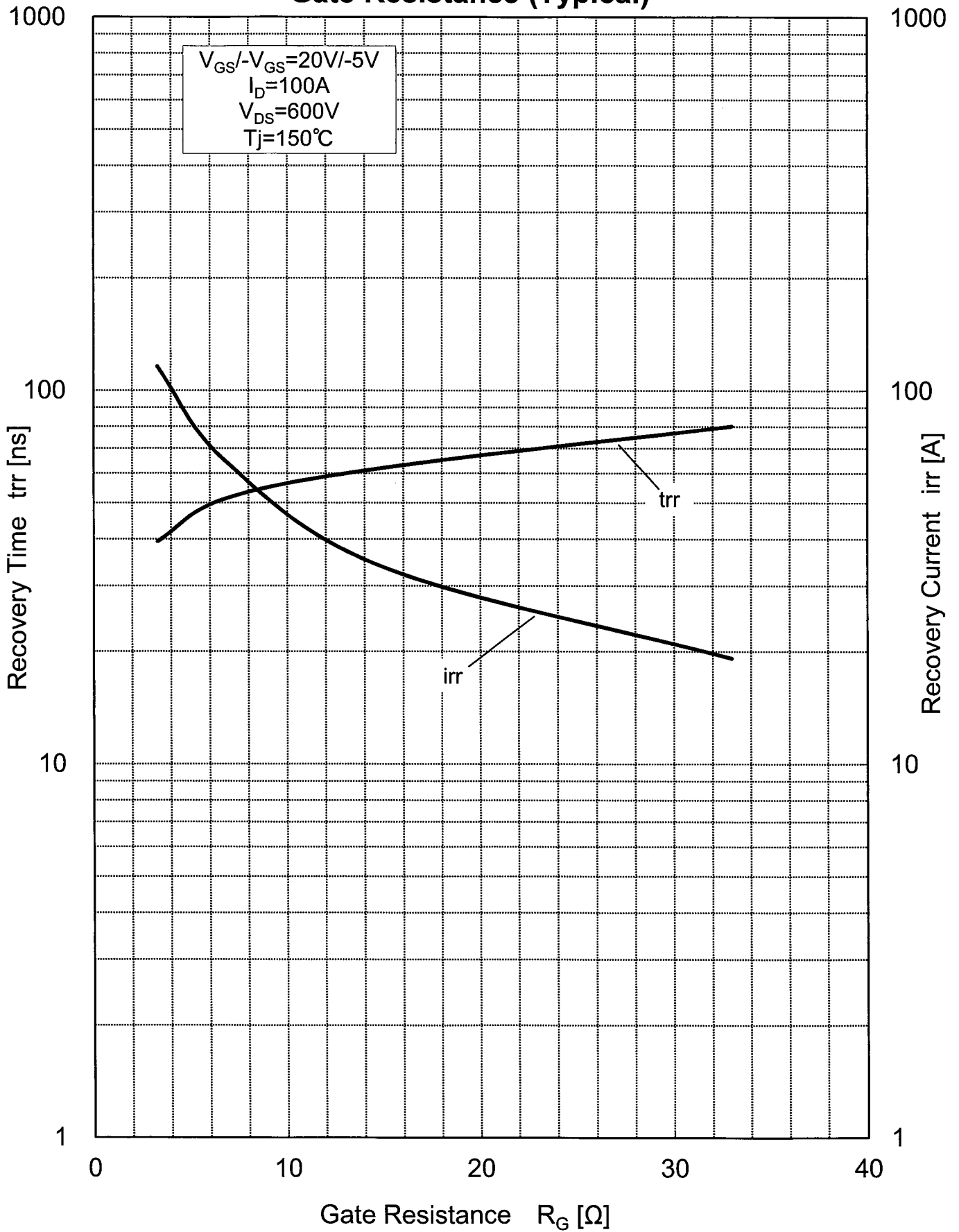
**Fig.40 Recovery Characteristics vs Gate Resistance (Typical)**



**Fig.41 Recovery Characteristics vs Gate Resistance (Typical)**



**Fig.42 Recovery Characteristics vs Gate Resistance (Typical)**



### Fig.43 Safe Operating Area

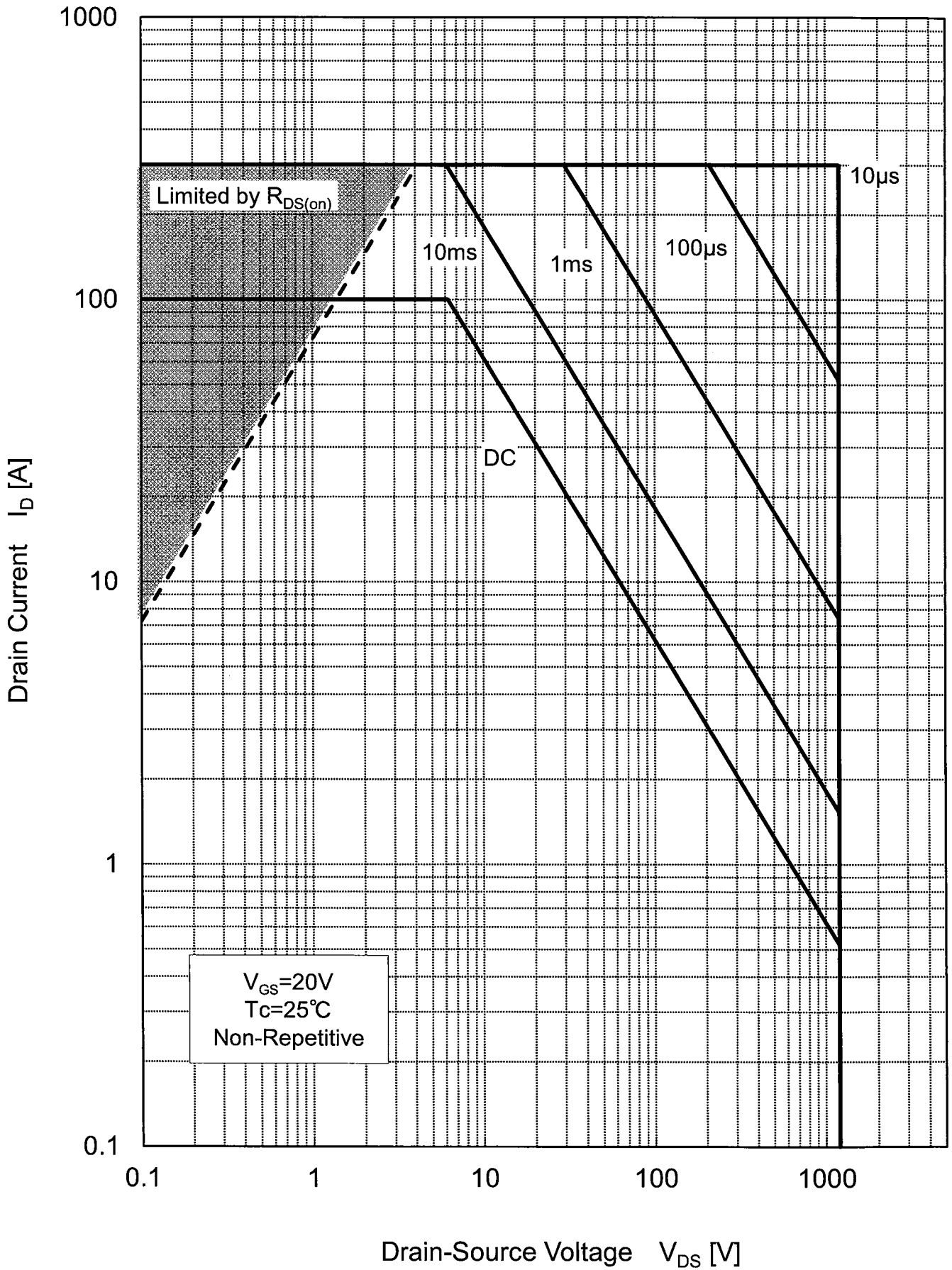


Fig.44 Transient Thermal Impedance

